

## 14-BIT, 170 MSPS ADC WITH DDR LVDS/CMOS OUTPUTS

### FEATURES

- Maximum Sample Rate: 170 MSPS
- 14-Bit Resolution
- No Missing Codes
- Total Power Dissipation 1.1 W
- Internal Sample and Hold
- 74-dBFS SNR at 70-MHz IF
- 85-dBc SFDR at 70-MHz IF, 0 dB gain
- 11.4 ENOB Minimum at 70-MHz IF
- Double Data Rate (DDR) LVDS and Parallel CMOS Output Options
- Programmable Gain up to 6 dB for SNR/SFDR Trade-Off at High IF
- Reduced Power Modes at Lower Sample Rates
- Supports input clock amplitude down to 400 mV<sub>pp</sub>
- Clock Duty Cycle Stabilizer
- No External Reference Decoupling Required
- Internal and External Reference Support
- Programmable Output Clock position to ease data capture
- 3.3-V Analog and Digital Supply
- 48-QFN Package (7 mm × 7 mm)

### APPLICATIONS

- Wireless Communications Infrastructure
- Software Defined Radio
- Power Amplifier Linearization
- 802.16d/e
- Test and Measurement Instrumentation
- High Definition Video
- Medical Imaging
- Radar Systems

### DESCRIPTION

ADS5545 is a high performance 14-bit, 170-MSPS A/D converter. It offers state-of-the-art functionality and performance using advanced techniques to minimize board space. Using an internal sample and hold and low jitter clock buffer, the ADC supports both high SNR and high SFDR at high input frequencies. It features programmable gain options that can be used to improve SFDR performance at lower full-scale analog input ranges.

In a compact 48-pin QFN, the device offers fully differential LVDS DDR (Double Data Rate) interface while parallel CMOS outputs can also be selected. Flexible output clock position programmability is available to ease capture and trade-off setup for hold times. At lower sampling rates, the ADC can be operated at scaled down power with no loss in performance. ADS5545 includes an internal reference, while eliminating the traditional reference pins and associated external decoupling. The device also supports an external reference mode.

The device is specified over the industrial temperature range (-40°C to 85°C).

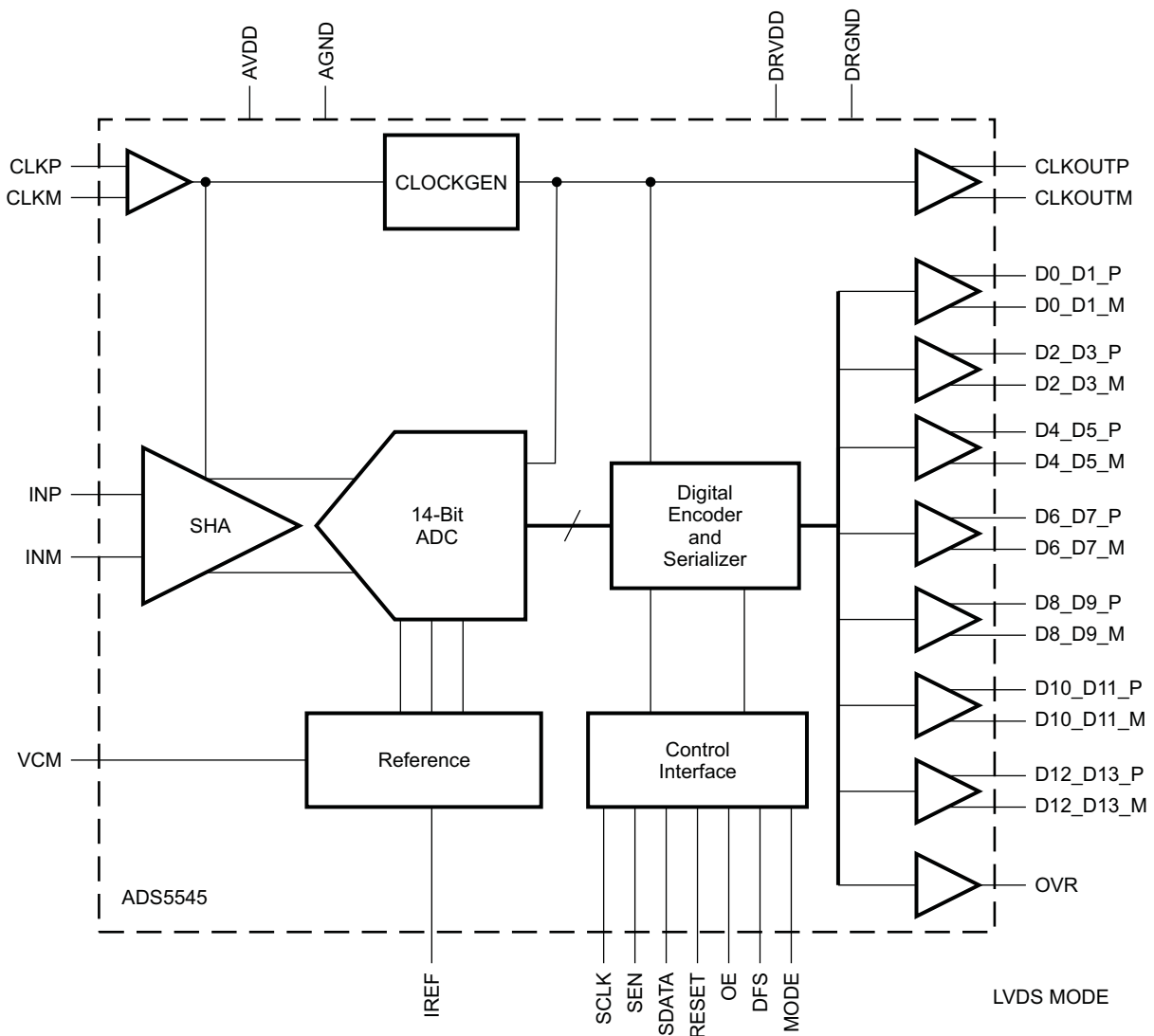


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.



### PACKAGE/ORDERING INFORMATION<sup>(1)</sup>

| PRODUCT | PACKAGE-LEAD          | PACKAGE DESIGNATOR | SPECIFIED TEMPERATURE RANGE | PACKAGE MARKING | ORDERING NUMBER | TRANSPORT MEDIA, QUANTITY |
|---------|-----------------------|--------------------|-----------------------------|-----------------|-----------------|---------------------------|
| ADS5545 | QFN-48 <sup>(2)</sup> | RGZ                | –40°C to 85°C               | AZ5545          | ADS5545IRGZT    | Tape and Reel, 250        |
|         |                       |                    |                             |                 | ADS5545IRGZR    | Tape and Reel, 2500       |

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at [www.ti.com](http://www.ti.com).
- (2) For thermal pad size on the package, see the mechanical drawings at the end of this data sheet.  $\theta_{JA} = 25.41^{\circ}\text{C/W}$  (0 LFM air flow),  $\theta_{JC} = 16.5^{\circ}\text{C/W}$  when used with 2 oz. copper trace and pad soldered directly to a JEDEC standard four layer 3 in x 3 in (7.62 cm x 7.62 cm) PCB.

## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

|                  |                                                         | VALUE                                 | UNIT |
|------------------|---------------------------------------------------------|---------------------------------------|------|
| V <sub>SS</sub>  | Supply voltage range, AVDD                              | –0.3 V to 3.9                         | V    |
|                  | Supply voltage range, DRVDD                             | –0.3 V to 3.9                         | V    |
|                  | Voltage between AGND and DRGND                          | –0.3 to 0.3                           | V    |
|                  | Voltage between AVDD to DRVDD                           | –0.3 to 3.3                           | V    |
|                  | Voltage applied to VCM pin (in external reference mode) | –0.3 to 1.8                           | V    |
|                  | Voltage applied to analog input pins, INP and INM       | –0.3 V to minimum (3.6, AVDD + 0.3 V) | V    |
|                  | Voltage applied to input clock pins, CLKP and CLKM      | –0.3 V to AVDD + 0.3 V                | V    |
| T <sub>A</sub>   | Operating free-air temperature range                    | –40 to 85                             | °C   |
| T <sub>J</sub>   | Operating junction temperature range                    | 125                                   | °C   |
| T <sub>stg</sub> | Storage temperature range                               | –65 to 150                            | °C   |

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

## RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

|                                                                                 | MIN                                                                                   | TYP      | MAX  | UNIT            |
|---------------------------------------------------------------------------------|---------------------------------------------------------------------------------------|----------|------|-----------------|
| <b>SUPPLIES</b>                                                                 |                                                                                       |          |      |                 |
| Analog supply voltage, AVDD                                                     | 3                                                                                     | 3.3      | 3.6  | V               |
| Digital supply voltage, DRVDD                                                   | 3                                                                                     | 3.3      | 3.6  | V               |
| <b>ANALOG INPUTS</b>                                                            |                                                                                       |          |      |                 |
| Differential input voltage range                                                |                                                                                       | 2        |      | V <sub>PP</sub> |
| Input common-mode voltage                                                       |                                                                                       | 1.5 ±0.1 |      | V               |
| Voltage applied on VCM in external reference mode                               | 1.45                                                                                  | 1.5      | 1.55 | V               |
| <b>CLOCK INPUT</b>                                                              |                                                                                       |          |      |                 |
| Input clock sample rate <sup>(1)</sup>                                          |                                                                                       |          |      |                 |
| DEFAULT SPEED mode                                                              | 50                                                                                    |          | 170  | MSPS            |
| LOW SPEED mode                                                                  | 1                                                                                     |          | 60   |                 |
| Input clock amplitude differential (V <sub>(CLKP)</sub> - V <sub>(CLKM)</sub> ) |                                                                                       |          |      |                 |
| Sine wave, ac-coupled                                                           | 0.4                                                                                   | 1.5      |      | V <sub>PP</sub> |
| LVPECL, ac-coupled                                                              |                                                                                       | 1.6      |      | V <sub>PP</sub> |
| LVDS, ac-coupled                                                                |                                                                                       | 0.7      |      | V <sub>PP</sub> |
| LVC MOS, single-ended, ac-coupled                                               |                                                                                       | 3.3      |      | V               |
| Input clock duty cycle (See <a href="#">Figure 33</a> )                         | 35%                                                                                   | 50%      | 65%  |                 |
| <b>DIGITAL OUTPUTS</b>                                                          |                                                                                       |          |      |                 |
| C <sub>L</sub>                                                                  | Maximum external load capacitance from each output pin to DRGND (LVDS and CMOS modes) |          |      |                 |
|                                                                                 | CMOS mode                                                                             | 5        |      | pF              |
|                                                                                 | LVDS mode, without internal termination (default after reset)                         | 5        |      | pF              |
|                                                                                 | LVDS mode, with internal termination <sup>(2)</sup>                                   | 10       |      | pF              |
| R <sub>L</sub>                                                                  | Differential load resistance between the LVDS output pairs (LVDS mode)                |          |      | Ω               |
|                                                                                 | Operating free-air temperature                                                        | –40      | 85   | °C              |

- (1) See section on *Low Sampling Frequency Operation* for more information

- (2) See section on *LVDS Buffer Internal Termination* for more information

## ELECTRICAL CHARACTERISTICS

Typical values are at 25°C, min and max values are across the full temperature range  $T_{MIN} = -40^{\circ}\text{C}$  to  $T_{MAX} = 85^{\circ}\text{C}$ ,  $AVDD = DRVDD = 3.3\text{ V}$ , sampling rate = 170 MSPS, sine wave input clock,  $1.5 V_{PP}$  differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0dB gain, DDR LVDS data output (unless otherwise noted)

| PARAMETER                 |                                                              | TEST CONDITIONS                                                              | MIN  | TYP      | MAX   | UNIT                        |
|---------------------------|--------------------------------------------------------------|------------------------------------------------------------------------------|------|----------|-------|-----------------------------|
| <b>RESOLUTION</b>         |                                                              |                                                                              |      | 14       |       | bits                        |
| <b>ANALOG INPUT</b>       |                                                              |                                                                              |      |          |       |                             |
|                           | Differential input voltage range                             |                                                                              |      | 2        |       | $V_{PP}$                    |
|                           | Differential input capacitance                               |                                                                              |      | 7        |       | pF                          |
|                           | Analog input bandwidth                                       | -3 dB, source impedance 50 $\Omega$                                          |      | 500      |       | MHz                         |
|                           | Analog input common mode current (per input pin)             |                                                                              |      | 280      |       | $\mu\text{A}$               |
| <b>REFERENCE VOLTAGES</b> |                                                              |                                                                              |      |          |       |                             |
| $V_{(REFB)}$              | Internal reference bottom voltage                            | Internal reference mode                                                      |      | 0.5      |       | V                           |
| $V_{(REFT)}$              | Internal reference top voltage                               | Internal reference mode                                                      |      | 2.5      |       | V                           |
| $\Delta V_{(REF)}$        | Internal reference error                                     | $V_{(REFT)} - V_{(REFB)}$                                                    | -60  | $\pm 25$ | 60    | mV                          |
| $V_{CM}$                  | Common mode output voltage                                   | Internal reference mode                                                      |      | 1.5      |       | V                           |
|                           | VCM output current capability                                | Internal reference mode                                                      |      | $\pm 4$  |       | mA                          |
| <b>DC ACCURACY</b>        |                                                              |                                                                              |      |          |       |                             |
|                           | No Missing Codes                                             |                                                                              |      | Assured  |       |                             |
| DNL                       | Differential non-linearity                                   |                                                                              | -0.9 | 0.5      | 2.5   | LSB                         |
| INL                       | Integral non-linearity                                       |                                                                              | -5   | $\pm 3$  | 5     | LSB                         |
|                           | Offset error                                                 |                                                                              | -10  | 5        | 10    | mV                          |
|                           | Offset temperature coefficient                               |                                                                              |      | 0.002    |       | ppm/ $^{\circ}\text{C}$     |
|                           | Gain error due to internal reference error alone             | $(\Delta V_{(REF)} / 2.0) \%$                                                | -3   | $\pm 1$  | 3     | % FS                        |
|                           | Gain error excluding internal reference error <sup>(1)</sup> |                                                                              | -2   | $\pm 1$  | 2     | % FS                        |
|                           | Gain temperature coefficient                                 |                                                                              |      | 0.01     |       | $\Delta\%/^{\circ}\text{C}$ |
| PSRR                      | DC Power supply rejection ratio                              |                                                                              |      | 0.6      |       | mV/V                        |
| <b>POWER SUPPLY</b>       |                                                              |                                                                              |      |          |       |                             |
| $I_{(AVDD)}$              | Analog supply current                                        |                                                                              |      | 281      |       | mA                          |
| $I_{(DRVDD)}$             | Digital supply current                                       | LVDS mode, $I_O = 3.5\text{ mA}$ , $R_L = 100\ \Omega$ , $C_L = 5\text{ pF}$ |      | 51       |       | mA                          |
| $I_{CC}$                  | Total supply current                                         | LVDS mode                                                                    |      | 332      |       | mA                          |
|                           | Total power dissipation                                      | LVDS mode                                                                    |      | 1.1      | 1.275 | W                           |
|                           | Standby power                                                | In STANDBY mode with input clock stopped                                     |      | 100      | 150   | mW                          |
|                           | Clock stop power                                             | With input clock stopped                                                     |      | 100      | 150   | mW                          |

(1) Gain error is specified from design and characterization; it is not tested in production.

## ELECTRICAL CHARACTERISTICS

Typical values are at 25°C, min and max values are across the full temperature range  $T_{MIN} = -40^{\circ}\text{C}$  to  $T_{MAX} = 85^{\circ}\text{C}$ ,  $AVDD = DRVDD = 3.3\text{ V}$ , sampling rate = 170 MSPS, sine wave input clock, 1.5  $V_{PP}$  differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0dB gain, DDR LVDS data output (unless otherwise noted)

| PARAMETER          |                                      | TEST CONDITIONS            |                                                | MIN  | TYP  | MAX | UNIT |
|--------------------|--------------------------------------|----------------------------|------------------------------------------------|------|------|-----|------|
| AC CHARACTERISTICS |                                      |                            |                                                |      |      |     |      |
| SNR                | Signal to noise ratio                | F <sub>IN</sub> = 10 MHz   |                                                |      | 74.3 |     | dBFS |
|                    |                                      | F <sub>IN</sub> = 70 MHz   |                                                | 71.5 | 74   |     |      |
|                    |                                      | F <sub>IN</sub> = 100 MHz  |                                                |      | 73.4 |     |      |
|                    |                                      | F <sub>IN</sub> = 150 MHz  |                                                |      | 72.8 |     |      |
|                    |                                      | F <sub>IN</sub> = 225 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS <sup>(1)</sup> |      | 71.3 |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 69.8 |     |      |
|                    |                                      | F <sub>IN</sub> = 300 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 70   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 69   |     |      |
| RMS output noise   |                                      | Inputs tied to common-mode |                                                |      | 1.1  |     | LSB  |
| SFDR               | Spurious free dynamic range          | F <sub>IN</sub> = 10 MHz   |                                                |      | 90   |     | dBc  |
|                    |                                      | F <sub>IN</sub> = 70 MHz   |                                                | 77   | 85   |     |      |
|                    |                                      | F <sub>IN</sub> = 100 MHz  |                                                |      | 85   |     |      |
|                    |                                      | F <sub>IN</sub> = 150 MHz  |                                                |      | 84   |     |      |
|                    |                                      | F <sub>IN</sub> = 225 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 75   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 78   |     |      |
|                    |                                      | F <sub>IN</sub> = 300 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 72   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 75   |     |      |
| SINAD              | Signal to noise and distortion ratio | F <sub>IN</sub> = 10 MHz   |                                                |      | 74.1 |     | dBFS |
|                    |                                      | F <sub>IN</sub> = 70 MHz   |                                                | 70.5 | 73   |     |      |
|                    |                                      | F <sub>IN</sub> = 100 MHz  |                                                |      | 72.8 |     |      |
|                    |                                      | F <sub>IN</sub> = 150 MHz  |                                                |      | 72.2 |     |      |
|                    |                                      | F <sub>IN</sub> = 225 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 69   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 68.9 |     |      |
|                    |                                      | F <sub>IN</sub> = 300 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 67.8 |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 67.5 |     |      |
| HD2                | Second harmonic                      | F <sub>IN</sub> = 10 MHz   |                                                |      | 91   |     | dBc  |
|                    |                                      | F <sub>IN</sub> = 70 MHz   |                                                | 77   | 90   |     |      |
|                    |                                      | F <sub>IN</sub> = 100 MHz  |                                                |      | 90   |     |      |
|                    |                                      | F <sub>IN</sub> = 150 MHz  |                                                |      | 88   |     |      |
|                    |                                      | F <sub>IN</sub> = 225 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 76   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 79   |     |      |
|                    |                                      | F <sub>IN</sub> = 300 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 73   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 75   |     |      |
| HD3                | Third harmonic                       | F <sub>IN</sub> = 10 MHz   |                                                |      | 90   |     | dBc  |
|                    |                                      | F <sub>IN</sub> = 70 MHz   |                                                | 77   | 85   |     |      |
|                    |                                      | F <sub>IN</sub> = 100 MHz  |                                                |      | 85   |     |      |
|                    |                                      | F <sub>IN</sub> = 150 MHz  |                                                |      | 84   |     |      |
|                    |                                      | F <sub>IN</sub> = 225 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 75   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 78   |     |      |
|                    |                                      | F <sub>IN</sub> = 300 MHz  | 0 dB gain, 2 V <sub>PP</sub> FS                |      | 72   |     |      |
|                    |                                      |                            | 3 dB gain, 1.4 V <sub>PP</sub> FS              |      | 75   |     |      |

(1) FS = Full scale range

**ELECTRICAL CHARACTERISTICS (continued)**

Typical values are at 25°C, min and max values are across the full temperature range  $T_{MIN} = -40^{\circ}\text{C}$  to  $T_{MAX} = 85^{\circ}\text{C}$ ,  $AVDD = DRVDD = 3.3\text{ V}$ , sampling rate = 170 MSPS, sine wave input clock, 1.5  $V_{PP}$  differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0dB gain, DDR LVDS data output (unless otherwise noted)

| PARAMETER                                    |  | TEST CONDITIONS                                                                             | MIN  | TYP  | MAX | UNIT         |
|----------------------------------------------|--|---------------------------------------------------------------------------------------------|------|------|-----|--------------|
| Worst harmonic (other than HD2, HD3)         |  | $F_{IN} = 10\text{ MHz}$                                                                    |      | 93   |     | dBc          |
|                                              |  | $F_{IN} = 70\text{ MHz}$                                                                    |      | 91   |     |              |
|                                              |  | $F_{IN} = 100\text{ MHz}$                                                                   |      | 90   |     |              |
|                                              |  | $F_{IN} = 150\text{ MHz}$                                                                   |      | 89   |     |              |
|                                              |  | $F_{IN} = 225\text{ MHz}$                                                                   |      | 87   |     |              |
|                                              |  | $F_{IN} = 300\text{ MHz}$                                                                   |      | 87   |     |              |
| THD      Total harmonic distortion           |  | $F_{IN} = 10\text{ MHz}$                                                                    |      | 86.5 |     | dBc          |
|                                              |  | $F_{IN} = 70\text{ MHz}$                                                                    | 75   | 82   |     |              |
|                                              |  | $F_{IN} = 100\text{ MHz}$                                                                   |      | 83   |     |              |
|                                              |  | $F_{IN} = 150\text{ MHz}$                                                                   |      | 82   |     |              |
|                                              |  | $F_{IN} = 225\text{ MHz}$                                                                   |      | 72   |     |              |
|                                              |  | $F_{IN} = 300\text{ MHz}$                                                                   |      | 68   |     |              |
| ENOB      Effective number of bits           |  | $F_{IN} = 10\text{ MHz}$                                                                    |      | 12   |     | bits         |
|                                              |  | $F_{IN} = 70\text{ MHz}$                                                                    | 11.4 | 11.8 |     |              |
| IMD      Two-tone intermodulation distortion |  | $F_{IN1} = 50.09\text{ MHz}$ , $F_{IN2} = 46.09\text{ MHz}$ , -7 dBFS each tone             |      | 92   |     | dBFS         |
|                                              |  | $F_{IN1} = 130.09\text{ MHz}$ , $F_{IN2} = 125.09\text{ MHz}$ , -7 dBFS each tone           |      | 90   |     |              |
| PSRR      AC power supply rejection ratio    |  | 30 MHz, 200 mV <sub>PP</sub> signal on 3.3-V supply                                         |      | 35   |     | dBc          |
| Voltage overload recovery time               |  | Recovery to 1% (of final value) for 6-dB overload with sine-wave input at Nyquist frequency |      | 1    |     | Clock cycles |

## DIGITAL CHARACTERISTICS<sup>(1)</sup>

The DC specifications refer to the condition where the digital outputs are not switching, but are permanently at a valid logic level 0 or 1 AVDD = DRVDD = 3.3 V, I<sub>O</sub> = 3.5 mA, R<sub>L</sub> = 100 Ω<sup>(2)</sup>

| PARAMETER                                           | TEST CONDITIONS                                                    | MIN | TYP  | MAX | UNIT |
|-----------------------------------------------------|--------------------------------------------------------------------|-----|------|-----|------|
| <b>DIGITAL INPUTS</b>                               |                                                                    |     |      |     |      |
| High-level input voltage                            |                                                                    | 2.4 |      |     | V    |
| Low-level input voltage                             |                                                                    |     |      | 0.8 | V    |
| High-level input current                            |                                                                    |     | 33   |     | μA   |
| Low-level input current                             |                                                                    |     | –33  |     | μA   |
| Input capacitance                                   |                                                                    |     | 4    |     | pF   |
| <b>DIGITAL OUTPUTS – CMOS MODE</b>                  |                                                                    |     |      |     |      |
| High-level output voltage                           |                                                                    |     | 3.3  |     | V    |
| Low-level output voltage                            |                                                                    |     | 0    |     | V    |
| Output capacitance                                  | Output capacitance inside the device, from each output to ground   |     | 2    |     | pF   |
| <b>DIGITAL OUTPUTS – LVDS MODE</b>                  |                                                                    |     |      |     |      |
| High-level output voltage                           |                                                                    |     | 1375 |     | mV   |
| Low-level output voltage                            |                                                                    |     | 1025 |     | mV   |
| Output differential voltage,  V <sub>OD</sub>       |                                                                    | 225 | 350  |     | mV   |
| V <sub>OS</sub> Output offset voltage, single-ended | Common-mode voltage of OUP and OUTM                                |     | 1200 |     | mV   |
| Output capacitance                                  | Output capacitance inside the device, from either output to ground |     | 2    |     | pF   |

(1) All LVDS and CMOS specifications are characterized, but not tested at production.

(2) I<sub>O</sub> refers to the LVDS buffer current setting; R<sub>L</sub> is the differential load resistance between the LVDS output pair.

## TIMING CHARACTERISTICS – LVDS AND CMOS MODES<sup>(1)</sup>

Typical values are at 25°C, min and max values are across the full temperature range T<sub>MIN</sub> = –40°C to T<sub>MAX</sub> = 85°C, AVDD = DRVDD = 3.3 V, sampling frequency = 170 MSPS, sine wave input clock, 1.5 V<sub>PP</sub> clock amplitude, C<sub>L</sub> = 5 pF<sup>(2)</sup>, I<sub>O</sub> = 3.5 mA, R<sub>L</sub> = 100 Ω<sup>(3)</sup>, no internal termination, unless otherwise noted.

For timings at lower sampling frequencies, see the *Output Timing* section in the APPLICATION INFORMATION of this data sheet.

| PARAMETER                      | TEST CONDITIONS                                                  | MIN | TYP | MAX | UNIT         |
|--------------------------------|------------------------------------------------------------------|-----|-----|-----|--------------|
| t <sub>a</sub> Aperture delay  |                                                                  |     | 1.2 |     | ns           |
| t <sub>j</sub> Aperture jitter |                                                                  |     | 150 |     | fs rms       |
| Wake-up time                   | Time to valid data after coming out of STANDBY mode              |     |     | 100 | μs           |
|                                | Time to valid data after stopping and restarting the input clock |     |     | 100 |              |
| Latency                        |                                                                  |     | 14  |     | clock cycles |

(1) Timing parameters are specified by design and characterization and not tested in production.

(2) C<sub>L</sub> is the effective external single-ended load capacitance between each output pin and ground.

(3) I<sub>O</sub> refers to the LVDS buffer current setting; R<sub>L</sub> is the differential load resistance between the LVDS output pair.

**TIMING CHARACTERISTICS – LVDS AND CMOS MODES (continued)**

For timings at lower sampling frequencies, see the *Output Timing* section in the APPLICATION INFORMATION of this data sheet.

| PARAMETER                          |                                                   | TEST CONDITIONS                                                                                                          | MIN | TYP | MAX | UNIT    |
|------------------------------------|---------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|---------|
| <b>DDR LVDS MODE<sup>(4)</sup></b> |                                                   |                                                                                                                          |     |     |     |         |
| $t_{su}$                           | Data setup time <sup>(5)</sup>                    | Data valid <sup>(6)</sup> to zero-cross of CLKOUTP                                                                       | 1.3 | 1.8 |     | ns      |
| $t_h$                              | Data hold time <sup>(5)</sup>                     | Zero-cross of CLKOUTP to data becoming invalid <sup>(6)</sup>                                                            | 0.5 | 1.0 |     | ns      |
| $t_{PDI}$                          | Clock propagation delay                           | Input clock rising edge zero-cross to output clock rising edge zero-cross                                                | 3.9 | 4.6 | 5.3 | ns      |
|                                    | LVDS bit clock duty cycle                         | Duty cycle of differential clock, (CLKOUTP-CLKOUTM)<br>$80 \leq F_s \leq 170$ MSPS                                       | 45% | 50% | 55% |         |
| $t_r$ ,<br>$t_f$                   | Data rise time,<br>Data fall time                 | Rise time measured from –50 mV to 50 mV<br>Fall time measured from 50 mV to –50 mV<br>$1 \leq F_s \leq 170$ MSPS         | 50  | 100 | 200 | ps      |
| $t_{CLKFALL}$ ,<br>$t_{CLKRISE}$   | Output clock fall time,<br>Output clock rise time | Rise time measured from –50 mV to 50 mV<br>Fall time measured from 50 mV to –50 mV<br>$1 \leq F_s \leq 170$ MSPS         | 50  | 100 | 200 | ps      |
| $t_{OE}$                           | Output enable (OE) to valid data delay            | Time to valid data after OE becomes active                                                                               |     |     | 1   | $\mu$ s |
| <b>PARALLEL CMOS MODE</b>          |                                                   |                                                                                                                          |     |     |     |         |
| $t_{su}$                           | Data setup time <sup>(5)(7)</sup>                 | Data valid <sup>(8)</sup> to 50% of CLKOUT rising edge                                                                   | 2.5 | 3.3 |     | ns      |
| $t_h$                              | Data hold time <sup>(5)(7)</sup>                  | 50% of CLKOUT rising edge to data becoming invalid <sup>(8)</sup>                                                        | 0.8 | 1.2 |     | ns      |
| $t_{PDI}$                          | Clock propagation delay <sup>(9)</sup>            | Input clock rising edge zero-cross to 50% of CLKOUT rising edge                                                          | 1.9 | 2.7 | 3.5 | ns      |
|                                    | Output clock duty cycle                           | Duty cycle of output clock (CLKOUT)<br>$80 \leq F_s \leq 170$ MSPS                                                       |     | 45% |     |         |
| $t_r$ ,<br>$t_f$                   | Data rise time,<br>Data fall time                 | Rise time measured from 20% to 80% of DRVDD<br>Fall time measured from 80% to 20% of DRVDD<br>$1 \leq F_s \leq 170$ MSPS | 0.8 | 1.5 | 2   | ns      |
| $t_{CLKRISE}$ ,<br>$t_{CLKFALL}$   | Output clock rise time,<br>Output clock fall time | Rise time measured from 20% to 80% of DRVDD<br>Fall time measured from 80% to 20% of DRVDD<br>$1 \leq F_s \leq 170$ MSPS | 0.4 | 0.8 | 1.2 | ns      |
| $t_{OE}$                           | Output enable (OE) to valid data delay            | Time to valid data after OE becomes active                                                                               |     |     | 50  | ns      |

(4) Measurements are done with a transmission line of 100  $\Omega$  characteristic impedance between the device and the load.

(5) Setup and hold time specifications take into account the effect of jitter on the output data and clock. These specifications also assume that the data and clock paths are perfectly matched within the receiver. Any mismatch in these paths within the receiver would appear as reduced timing margin.

(6) Data valid refers to logic high of 50 mV and logic low of –50 mV.

(7) Setup and hold times are specified with default output clock and data positions. For other positions, the timing numbers have to be adjusted appropriately.

(8) Data valid refers to logic high of 2 V and logic low of 0.8 V

(9) Clock propagation delay timings are specified with default output clock positions. For other positions, the timing numbers have to be adjusted appropriately.



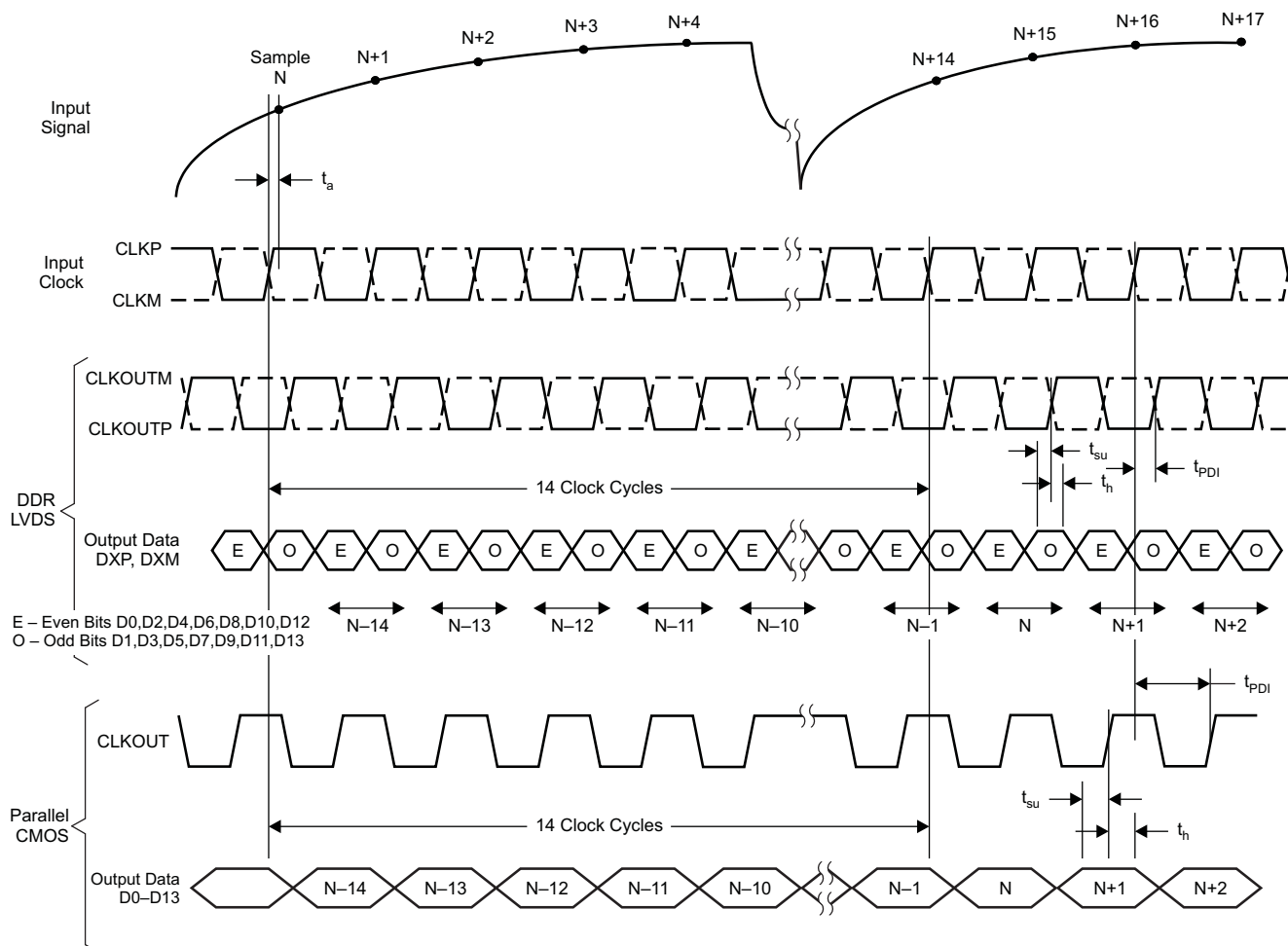
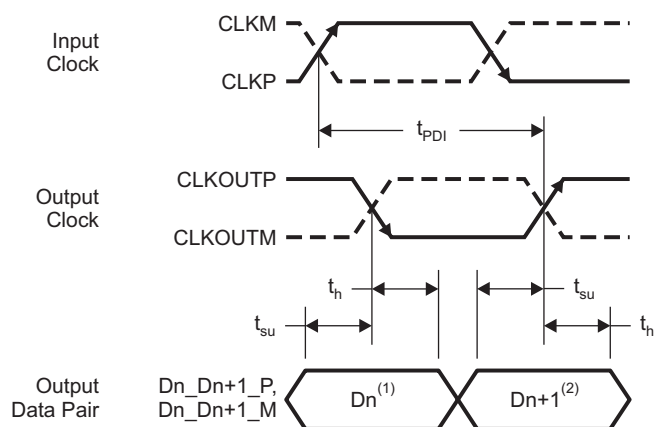


Figure 1. Latency

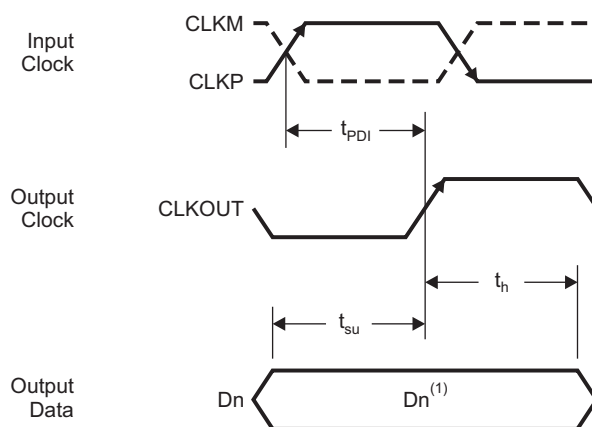


<sup>(1)</sup>  $D_n$  – Bits D0, D2, D4, D6, D8, D10, D12

<sup>(2)</sup>  $D_{n+1}$  – Bits D1, D3, D5, D7, D9, D11, D13

T0106-01

Figure 2. LVDS Mode Timing



<sup>(1)</sup>Dn – Bits D0–D13

T0107-01

**Figure 3. CMOS Mode Timing**

## DEVICE PROGRAMMING MODES

ADS5545 offers flexibility with several programmable features that are easily configured.

The device can be configured independently using either a parallel interface control or a serial interface programming.

In addition, the device supports a third configuration mode, where both the parallel interface and the serial control registers are used. In this mode, the priority between the parallel and serial interfaces is determined by a priority table (Table 2). If this additional level of flexibility is not required, the user can select either the serial interface programming or the parallel interface control.

## USING PARALLEL INTERFACE CONTROL ONLY

To control the device using parallel interface, keep RESET tied to **high** (DRVDD). Pins DFS, MODE, SEN, SCLK, and SDATA are used to directly control certain modes of the ADC. The device is configured by connecting the parallel pins to the correct voltage levels (as described in Table 3 to Table 7). The voltage levels can be derived by using a resistor string as illustrated in Figure 4. There is no need to apply reset.

In this mode, SEN, SCLK, and SDATA function as parallel interface control pins. Frequently used functions are controlled in this mode—standby, selection between LVDS/CMOS output format, internal/external reference, two's complement/straight binary output format, and position of the output clock edge.

Table 1 has a description of the modes controlled by the four parallel pins.

**Table 1. Parallel Pin Definition**

| PIN   | CONTROL MODES                                                                        |
|-------|--------------------------------------------------------------------------------------|
| DFS   | DATA FORMAT and the LVDS/CMOS output interface                                       |
| MODE  | Internal or external reference                                                       |
| SEN   | CLKOUT edge programmability                                                          |
| SCLK  | LOW SPEED mode control for low sampling frequencies (< 50 MSPS)                      |
| SDATA | STANDBY mode – Global (ADC, internal references and output buffers are powered down) |

## USING SERIAL INTERFACE PROGRAMMING ONLY

To program using the serial interface, the internal registers must first be reset to their default values, and the RESET pin must be kept **low**. In this mode, SEN, SDATA, and SCLK function as serial interface pins and are used to access the internal registers of ADC. The registers are reset either by applying a pulse on the RESET pin, or by a **high** setting on the <RST> bit (D1 in register 0x6C). The *serial interface section* describes the register programming and register reset in more detail.

Since the parallel pins DFS and MODE are not used in this mode, they must be tied to ground.

## USING BOTH THE SERIAL INTERFACE AND PARALLEL CONTROLS

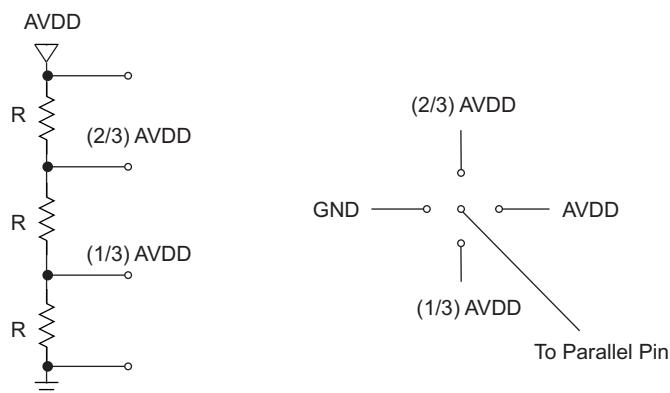
For increased flexibility, a combination of serial interface registers and parallel pin controls (DFS, MODE) are used to configure the device.

The serial registers must first be reset to their default values, and the RESET pin must be kept **low**. In this mode, SEN, SDATA, and SCLK function as serial interface pins and are used to access the internal registers of ADC. The registers are reset either by applying a pulse on RESET pin or by a **high** setting on the <RST> bit (D1 in register 0x6C). The *serial interface section* describes the register programming and register reset in more detail.

The parallel interface control pins DFS and MODE are used, and their function is determined by the appropriate voltage levels as described in Table 6 and Table 7. The voltage levels are derived by using a resistor string as illustrated in Figure 4. Since some functions are controlled using both the parallel pins and serial registers, the priority between the two is determined by a priority table (Table 2).

**Table 2. Priority Between Parallel Pins and Serial Registers**

| PIN  | FUNCTIONS SUPPORTED         | PRIORITY                                                                                                                                |
|------|-----------------------------|-----------------------------------------------------------------------------------------------------------------------------------------|
| MODE | Internal/External reference | When using the serial interface, bit <REF> (register 0x6D, bit D4) controls this mode, ONLY if the MODE pin is tied low.                |
| DFS  | DATA FORMAT                 | When using the serial interface, bit <DF> (register 0x63, bit D3) controls this mode, ONLY if the DFS pin is tied low.                  |
|      | LVDS/CMOS                   | When using the serial interface, bit <ODI> (register 0x6C, bits D3-D4) controls LVDS/CMOS selection independent of the state of DFS pin |

**Figure 4. Simple Scheme to Configure Parallel Pins**

## DESCRIPTION OF PARALLEL PINS

**Table 3. SCLK Control Pin**

| SCLK (Pin 29) | DESCRIPTION                                                      |
|---------------|------------------------------------------------------------------|
| 0             | DEFAULT SPEED - Must be used for sampling frequencies > 50 MSPS. |
| DRVDD         | LOW SPEED - Must be used for sampling frequencies ≤ 50 MSPS.     |

**Table 4. SDATA Control Pin**

| SDATA (Pin 28) | DESCRIPTION                                                                                                   |
|----------------|---------------------------------------------------------------------------------------------------------------|
| 0              | Normal operation (Default)                                                                                    |
| DRVDD          | STANDBY. This is a global power down, where ADC, internal references and the output buffers are powered down. |

**Table 5. SEN Control Pin**

| SEN (Pin 27) | DESCRIPTION                                                                                                                       |
|--------------|-----------------------------------------------------------------------------------------------------------------------------------|
| 0            | <b>CMOS mode:</b> CLKOUT edge later by (3/12)Ts <sup>(1)</sup> ; <b>LVDS mode:</b> CLKOUT edge aligned with data transition       |
| (1/3)DRVDD   | <b>CMOS mode:</b> CLKOUT edge later by (2/12)Ts <sup>(1)</sup> ; <b>LVDS mode:</b> CLKOUT edge aligned with data transition       |
| (2/3)DRVDD   | <b>CMOS mode:</b> CLKOUT edge later by (1/12)Ts <sup>(1)</sup> ; <b>LVDS mode:</b> CLKOUT edge earlier by (1/12)Ts <sup>(1)</sup> |
| DRVDD        | Default CLKOUT position                                                                                                           |

(1) Ts = 1/Sampling Frequency

**Table 6. DFS Control Pin**

| DFS (Pin 6) | DESCRIPTION                                       |
|-------------|---------------------------------------------------|
| 0           | 2's complement data and DDR LVDS output (Default) |
| (1/3)DRVDD  | 2's complement data and parallel CMOS output      |
| (2/3)DRVDD  | Offset binary data and parallel CMOS output       |
| DRVDD       | Offset binary data and DDR LVDS output            |

**Table 7. MODE Control Pin**

| MODE (Pin 23) | DESCRIPTION        |
|---------------|--------------------|
| 0             | Internal reference |
| (1/3)AVDD     | External reference |
| (2/3)AVDD     | External reference |
| AVDD          | Internal reference |

## SERIAL INTERFACE

The ADC has a set of internal registers, which can be accessed through the serial interface formed by pins SEN (Serial interface Enable), SCLK (Serial Interface Clock), SDATA (Serial Interface Data) and RESET. After device power-up, the internal registers must be reset to their default values by applying a high-going pulse on RESET (of width greater than 10 ns).

Serial shift of bits into the device is enabled when SEN is low. Serial data SDATA is latched at every falling edge of SCLK when SEN is active (low). The serial data is loaded into the register at every 16th SCLK falling edge when SEN is low. If the word length exceeds a multiple of 16 bits, the excess bits are ignored. Data is loaded in multiples of 16-bit words within a single active SEN pulse.

The first 8 bits form the register address and the remaining 8 bits form the register data. The interface can work with SCLK frequency from 20 MHz down to very low speeds (few Hertz) and also with non-50% SCLK duty cycle.

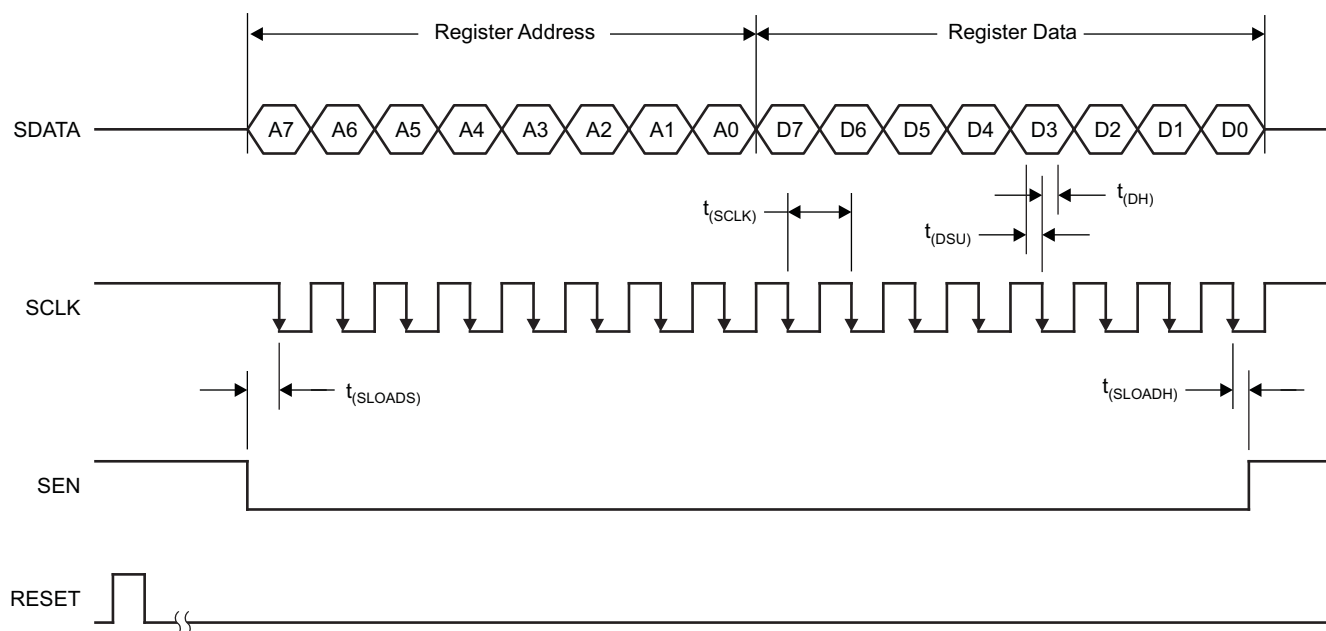
## REGISTER INITIALIZATION

After power-up, the internal registers *must* be reset to their default values. This is done in one of two ways:

1. Either through hardware reset by applying a high-going pulse on RESET pin (of width greater than 10 ns) as shown in [Figure 5](#).

OR

2. By applying software reset. Using the serial interface, set the <RST> bit (D1 in register 0x6C) to **high**. This initializes the internal registers to their default values and then self-resets the <RST> bit to **low**. In this case the RESET pin is kept **low**.



T0109-01

**Figure 5. Serial Interface Timing Diagram**

## SERIAL INTERFACE TIMING CHARACTERISTICS

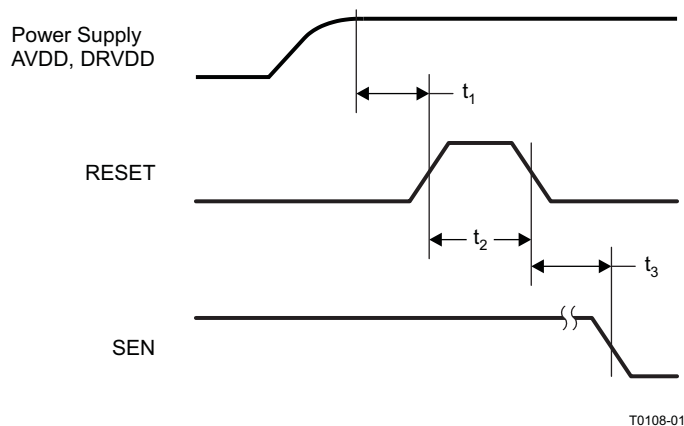
Typical values at 25°C, min and max values across the full temperature range  $T_{MIN} = -40^{\circ}\text{C}$  to  $T_{MAX} = 85^{\circ}\text{C}$ ,  
AVDD = DRVDD = 3.3 V (unless otherwise noted)

|              |                        | MIN  | TYP | MAX | UNIT |
|--------------|------------------------|------|-----|-----|------|
| $f_{SCLK}$   | SCLK frequency         | > DC |     | 20  | MHz  |
| $t_{SLOADS}$ | SEN to SCLK setup time |      | 25  |     | ns   |
| $t_{SLOADH}$ | SCLK to SEN hold time  |      | 25  |     | ns   |
| $t_{DSU}$    | SDATA setup time       |      | 25  |     | ns   |
| $t_{DH}$     | SDATA hold time        |      | 25  |     | ns   |

## RESET TIMING

Typical values at 25°C, min and max values across the full temperature range  $T_{MIN} = -40^{\circ}\text{C}$  to  $T_{MAX} = 85^{\circ}\text{C}$ ,  
AVDD = DRVDD = 3.3 V (unless otherwise noted)

| PARAMETER | TEST CONDITIONS      | MIN                                                         | TYP | MAX | UNIT |
|-----------|----------------------|-------------------------------------------------------------|-----|-----|------|
| $t_1$     | Power-on delay       | Delay from power-up of AVDD and DRVDD to RESET pulse active | 5   |     | ms   |
| $t_2$     | Reset pulse width    | Pulse width of active RESET signal                          | 10  |     | ns   |
| $t_3$     | Register write delay | Delay from RESET disable to SEN active                      | 25  |     | ns   |
| $t_{PO}$  | Power-up time        | Delay from power-up of AVDD and DRVDD to output stable      | 6.5 |     | ms   |



T0108-01

NOTE: A high-going pulse on RESET pin is required in serial interface mode in case of initialization through hardware reset.  
For parallel interface operation, RESET has to be tied permanently HIGH.

**Figure 6. Reset Timing Diagram**

**SERIAL REGISTER MAP**

Table 8 gives a snapshot of all the functions that can be programmed through the serial interface.

**Table 8. Summary of Functions Supported by Serial Interface <sup>(1)(2)</sup>**

| REGISTER ADDRESS IN HEX | REGISTER FUNCTIONS                                            |                                                     |                                                      |                                                         |                                                   |    |                                             |    |
|-------------------------|---------------------------------------------------------------|-----------------------------------------------------|------------------------------------------------------|---------------------------------------------------------|---------------------------------------------------|----|---------------------------------------------|----|
| A7 - A0                 | D7                                                            | D6                                                  | D5                                                   | D4                                                      | D3                                                | D2 | D1                                          | D0 |
| 62                      |                                                               | <DATA POSN><br>OUTPUT DATA POSITION PROGRAMMABILITY |                                                      | <CLKOUT POSN><br>OUTPUT CLOCK POSITION PROGRAMMABILITY  |                                                   |    |                                             |    |
| 63                      | <STBY><br>GLOBAL POWER DOWN                                   |                                                     |                                                      | <LOW SPEED><br>ENABLE LOW SAMPLING FREQUENCY OPERATION  | <DF><br>DATA FORMAT - 2's COMP or STRAIGHT BINARY |    |                                             |    |
| 65                      | <TEST PATTERN> – ALL 0S, ALL 1s, TOGGLE, RAMP, CUSTOM PATTERN |                                                     |                                                      |                                                         |                                                   |    |                                             |    |
| 68                      |                                                               |                                                     |                                                      |                                                         | <GAIN> GAIN PROGRAMMING <GAIN> - 1 dB to 6 dB     |    |                                             |    |
| 69                      | <CUSTOM A> CUSTOM PATTERN (D7 TO D0)                          |                                                     |                                                      |                                                         |                                                   |    |                                             |    |
| 6A                      |                                                               |                                                     | <CUSTOM B> CUSTOM PATTERN (D13 TO D8)                |                                                         |                                                   |    |                                             |    |
| 6B                      |                                                               |                                                     | <CLKIN GAIN> INPUT CLOCK BUFFER GAIN PROGRAMMABILITY |                                                         |                                                   |    |                                             |    |
| 6C                      |                                                               |                                                     |                                                      | <ODI> OUTPUT DATA INTERFACE - DDR LVDS or PARALLEL CMOS |                                                   |    | <RST><br>SOFTWARE RESET                     |    |
| 6D                      | <SCALING> POWER SCALING                                       |                                                     |                                                      | <REF><br>INTERNAL or EXTERNAL REFERENCE                 |                                                   |    |                                             |    |
| 7E                      | <DATA TERM><br>INTERNAL TERMINATION – DATA OUTPUTS            |                                                     |                                                      | <CLKOUT TERM><br>INTERNAL TERMINATION – OUTPUT CLOCK    |                                                   |    | <LVDS CURR><br>LVDS CURRENT PROGRAMMABILITY |    |
| 7F                      | <CURR DOUBLE><br>LVDS CURRENT DOUBLE                          |                                                     |                                                      |                                                         |                                                   |    |                                             |    |

(1) The unused bits in each register (shown by blank cells in above table) must be programmed as '0'.

(2) Multiple functions in a register can be programmed in a single write operation.



## DESCRIPTION OF SERIAL REGISTERS

Each register function is explained in detail below.

**Table 9. Serial Register A**

| A7 - A0 (hex) | D7 | D6                                                        | D5 | D4                                                     | D3 | D2 | D1 | D0 |
|---------------|----|-----------------------------------------------------------|----|--------------------------------------------------------|----|----|----|----|
| 62            |    | <DATA POSN><br>OUTPUT DATA<br>POSITION<br>PROGRAMMABILITY |    | <CLKOUT POSN><br>OUTPUT CLOCK POSITION PROGRAMMABILITY |    |    |    |    |

### D4 - D0

#### <CLKOUT POSN> [Output clock position programmability](#)

|       |                                                                                                                                     |
|-------|-------------------------------------------------------------------------------------------------------------------------------------|
| 00001 | Default CLKOUT position after reset. Setup/hold timings with this clock position are specified in the timing characteristics table. |
| XX011 | <b>CMOS</b> – Rising edge later by (1/12) Ts<br><b>LVDS</b> – Rising edge earlier by (1/12) Ts                                      |
| XX101 | <b>CMOS</b> – Rising edge later by (3/12) Ts<br><b>LVDS</b> – Rising edge aligned with data transition                              |
| XX111 | <b>CMOS</b> – Rising edge later by (2/12) Ts<br><b>LVDS</b> – Rising edge aligned with data transition                              |
| 01XX1 | <b>CMOS</b> – Rising edge later by (1/12) Ts<br><b>LVDS</b> – Rising edge earlier by (1/12) Ts                                      |
| 10XX1 | <b>CMOS</b> – Rising edge later by (3/12) Ts<br><b>LVDS</b> – Rising edge aligned with data transition                              |
| 11XX1 | <b>CMOS</b> – Rising edge later by (2/12) Ts<br><b>LVDS</b> – Rising edge aligned with data transition                              |

### D6 – D5

#### <DATA POSN> [Output data position programmability \(Only in CMOS mode\)](#)

|    |                                                                                                                                                           |
|----|-----------------------------------------------------------------------------------------------------------------------------------------------------------|
| 00 | Data Position 1 - Default output data position after reset. Setup/hold timings with this data position are specified in the timing characteristics table. |
| 01 | Data Position 2 - Setup time increases by (2/36) Ts                                                                                                       |
| 10 | Data Position 3 - Setup time increases by (5/36) Ts                                                                                                       |
| 11 | Data Position 4 - Setup time decreases by (6/36) Ts                                                                                                       |

**Table 10. Serial Register B**

| A7 - A0 (hex) | D7                                | D6 | D5 | D4                                                              | D3                                                          | D2 | D1 | D0 |
|---------------|-----------------------------------|----|----|-----------------------------------------------------------------|-------------------------------------------------------------|----|----|----|
| 63            | <STBY><br>GLOBAL<br>POWER<br>DOWN |    |    | <LOW SPEED><br>ENABLE LOW<br>SAMPLING<br>FREQUENCY<br>OPERATION | <DF><br>DATA<br>FORMAT<br>2's COMP or<br>STRAIGHT<br>BINARY |    |    |    |

|           |                                                                          |
|-----------|--------------------------------------------------------------------------|
| <b>D3</b> | <b>&lt;DF&gt; Output data format</b>                                     |
| 0         | 2's complement                                                           |
| 1         | Straight binary                                                          |
| <b>D4</b> | <b>&lt;LOW SPEED&gt; Low sampling frequency operation</b>                |
| 0         | Default SPEED mode for $50 < F_s \leq 190$ MSPS                          |
| 1         | Low SPEED mode $1 \leq F_s \leq 50$ MSPS                                 |
| <b>D7</b> | <b>&lt;STBY&gt; Global power down</b>                                    |
| 0         | Normal operation                                                         |
| 1         | Global power down (includes ADC, internal references and output buffers) |

**Table 11. Serial Register C**

| A7 - A0 (hex) | D7                                                               | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|---------------|------------------------------------------------------------------|----|----|----|----|----|----|----|
| 65            | <TEST PATTERNS>— ALL 0s, ALL 1s,<br>TOGGLE, RAMP, CUSTOM PATTERN |    |    |    |    |    |    |    |

|                |                                                                                      |
|----------------|--------------------------------------------------------------------------------------|
| <b>D7 - D5</b> | <b>&lt;TEST PATTERN&gt; Outputs selected test pattern on data lines</b>              |
| 000            | Normal operation                                                                     |
| 001            | All 0s                                                                               |
| 010            | All 1s                                                                               |
| 011            | Toggle pattern – alternate 1s and 0s on each data output and across data outputs     |
| 100            | Ramp pattern – Output data ramps from 0x0000 to 0x3FFF by one code every clock cycle |
| 101            | Custom pattern – Outputs the custom pattern in CUSTOM PATTERN registers A and B      |
| 111            | Unused                                                                               |

**Table 12. Serial Register D**

| A7 - A0 (hex) | D7 | D6 | D5 | D4 | D3                                            | D2 | D1 | D0 |
|---------------|----|----|----|----|-----------------------------------------------|----|----|----|
| 68            |    |    |    |    | <GAIN> GAIN PROGRAMMING <GAIN> - 1 dB to 6 dB |    |    |    |

**D3 - D0**      **<GAIN> [Gain programmability](#)**

|      |                                |
|------|--------------------------------|
| 1000 | 0 dB gain, default after reset |
| 1001 | 1 dB                           |
| 1010 | 2 dB                           |
| 1011 | 3 dB                           |
| 1100 | 4 dB                           |
| 1101 | 5 dB                           |
| 1110 | 6 dB                           |

**Table 13. Serial Register E**

| A7 - A0 (hex) | D7                                   | D6 | D5                                    | D4 | D3 | D2 | D1 | D0 |
|---------------|--------------------------------------|----|---------------------------------------|----|----|----|----|----|
| 69            | <CUSTOM A> CUSTOM PATTERN (D7 TO D0) |    |                                       |    |    |    |    |    |
| 6A            |                                      |    | <CUSTOM B> CUSTOM PATTERN (D13 TO D8) |    |    |    |    |    |

Reg 69      D7 – D0      Program bits D7 to D0 of custom pattern

Reg 6A      D5 – D0      Program bits D13 to D8 of custom pattern

**Table 14. Serial Register F**

| A7 - A0 (hex) | D7 | D6 | D5                                                   | D4 | D3 | D2 | D1 | D0 |
|---------------|----|----|------------------------------------------------------|----|----|----|----|----|
| 6B            |    |    | <CLKIN GAIN> INPUT CLOCK BUFFER GAIN PROGRAMMABILITY |    |    |    |    |    |

**D5 - D0**      **<CLKIN GAIN> [Input clock buffer gain programming](#)**

|        |                            |
|--------|----------------------------|
| 110010 | Gain 4, maximum gain       |
| 101010 | Gain 3                     |
| 100110 | Gain 2                     |
| 100000 | Gain1, default after reset |
| 100011 | Gain 0 minimum gain        |

**Table 15. Serial Register G**

| A7 - A0 (hex) | D7 | D6 | D5 | D4                                                            | D3 | D2 | D1                         | D0 |
|---------------|----|----|----|---------------------------------------------------------------|----|----|----------------------------|----|
| 6C            |    |    |    | <ODI> OUTPUT DATA<br>INTERFACE - DDR LVDS OR<br>PARALLEL CMOS |    |    | <RST><br>SOFTWARE<br>RESET |    |

**D1**

**<RST> Software resets the ADC**

1 Resets all registers to default values

**D4 - D3**

**<ODI> [Output data interface](#)**

00 DDR LVDS outputs, default after reset

01 DDR LVDS outputs

11 Parallel CMOS outputs

**Table 16. Serial Register H**

| A7 - A0 | D7                      | D6 | D5 | D4                                      | D3 | D2 | D1 | D0 |
|---------|-------------------------|----|----|-----------------------------------------|----|----|----|----|
| 6D      | <SCALING> POWER SCALING |    |    | <REF> INTERNAL or<br>EXTERNAL REFERENCE |    |    |    |    |

**D4**

**<REF> [Reference](#)**

0 Internal reference

1 External reference mode, force voltage on Vcm to set reference.

**D7 - D5**

**<SCALING> [Program power scaling at lower sampling frequencies](#)**

001 Use for  $F_s > 150$  MSPS, default after reset

011 Power Mode 1, use for  $105 < F_s \leq 150$  MSPS

101 Power Mode 2, use for  $50 < F_s \leq 105$

111 Power Mode 3, use for  $F_s \leq 50$  MSPS

**Table 17. Serial Register I**

| A7 - A0 | D7                                                 | D6 | D5 | D4                                                   | D3 | D2 | D1                                             | D0 |
|---------|----------------------------------------------------|----|----|------------------------------------------------------|----|----|------------------------------------------------|----|
| 7E      | <DATA TERM> INTERNAL TERMINATION –<br>DATA OUTPUTS |    |    | <CLKOUT TERM> INTERNAL<br>TERMINATION – OUTPUT CLOCK |    |    | <LVDS CURR> LVDS<br>CURRENT<br>PROGRAMMABILITY |    |

**D1 - D0**

**<LVDS CURR> [LVDS buffer current programming](#)**

00 3.5 mA, default

01 2.5 mA

10 4.5 mA

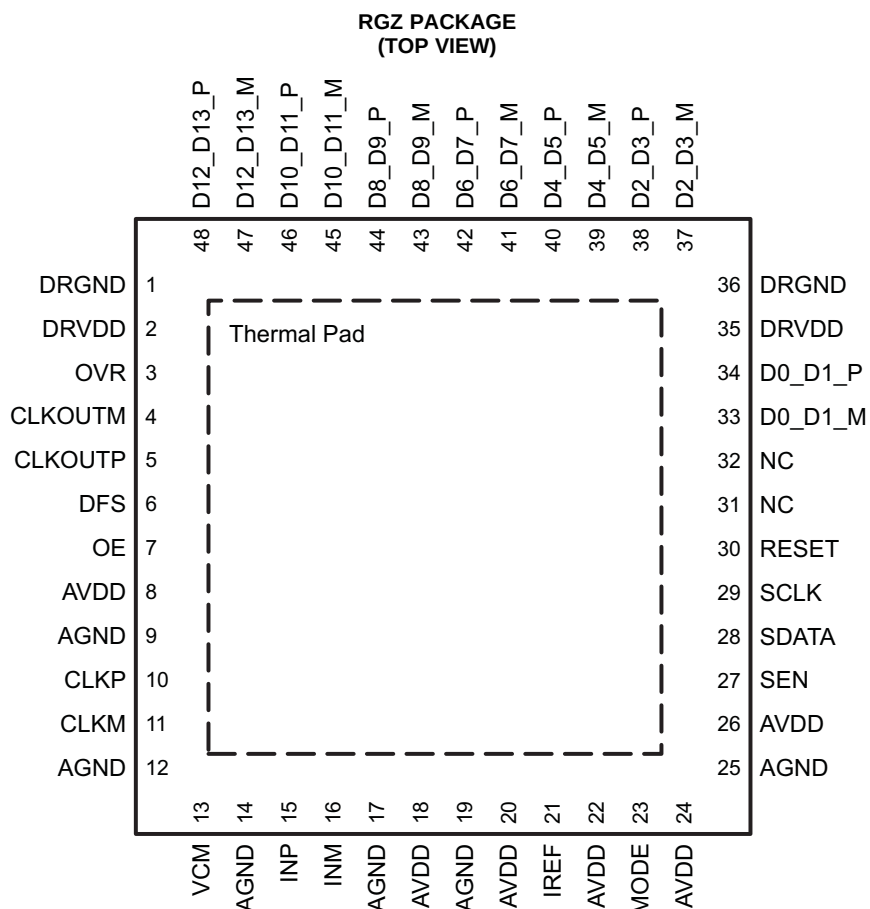
11 1.75 mA

| <b>D4 - D2</b> | <b>&lt;CLKOUT TERM&gt; Program internal termination for output clock (CLKOUT pin) buffer</b> |
|----------------|----------------------------------------------------------------------------------------------|
| 000            | No internal termination                                                                      |
| 001            | 325                                                                                          |
| 010            | 200                                                                                          |
| 011            | 125                                                                                          |
| 100            | 170                                                                                          |
| 101            | 120                                                                                          |
| 110            | 100                                                                                          |
| 111            | 75                                                                                           |
| <b>D7 - D5</b> | <b>&lt;DATA TERM&gt; Program internal termination for data buffers</b>                       |
| 000            | No internal termination                                                                      |
| 001            | 325                                                                                          |
| 010            | 200                                                                                          |
| 011            | 125                                                                                          |
| 100            | 170                                                                                          |
| 101            | 120                                                                                          |
| 110            | 100                                                                                          |
| 111            | 75                                                                                           |

**Table 18. Serial Register J**

| A7 - A0 | D7                                   | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|---------|--------------------------------------|----|----|----|----|----|----|----|
| 7F      | <CURR DOUBLE> LVDS<br>CURRENT DOUBLE |    |    |    |    |    |    |    |

| <b>D7 - D6</b> | <b>&lt;CURR DOUBLE&gt; LVDS buffer current doubling</b> |
|----------------|---------------------------------------------------------|
| 00             | Value specified by <LVDS CURR>                          |
| 01             | 2x data, 2x clockout currents                           |
| 10             | 1x data, 2x clockout currents                           |
| 11             | 2x data, 4x clockout currents                           |

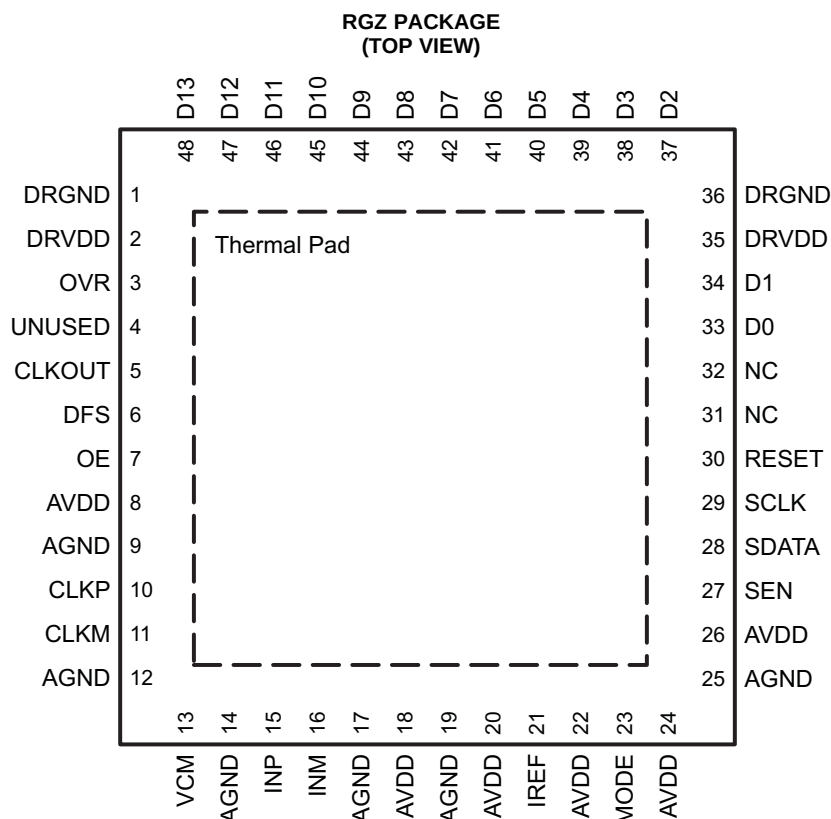
**PIN CONFIGURATION (LVDS MODE)****Figure 7. LVDS Mode Pinout****PIN ASSIGNMENTS – LVDS Mode**

| PIN NAME   | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                                                                                                                                   | PIN TYPE | PIN NUMBER            | NUMBER OF PINS |
|------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|-----------------------|----------------|
| AVDD       | Analog power supply                                                                                                                                                                                                                                                                                                                                                                                                                                                           | I        | 8, 18, 20, 22, 24, 26 | 6              |
| AGND       | Analog ground                                                                                                                                                                                                                                                                                                                                                                                                                                                                 | I        | 9, 12, 14, 17, 19, 25 | 6              |
| CLKP, CLKM | Differential clock input                                                                                                                                                                                                                                                                                                                                                                                                                                                      | I        | 10, 11                | 2              |
| INP, INM   | Differential analog input                                                                                                                                                                                                                                                                                                                                                                                                                                                     | I        | 15, 16                | 2              |
| VCM        | Internal reference mode – Common-mode voltage output.<br>External reference mode – Reference input. The voltage forced on this pin sets the internal references.                                                                                                                                                                                                                                                                                                              | I/O      | 13                    | 1              |
| IREF       | Current-set resistor, 56.2-kΩ resistor to ground.                                                                                                                                                                                                                                                                                                                                                                                                                             | I        | 21                    | 1              |
| RESET      | Serial interface RESET input.<br>When using the serial interface mode, the user MUST initialize internal registers through hardware RESET by applying a high-going pulse on this pin, or by using the software reset option. See the <i>SERIAL INTERFACE</i> section.<br>In parallel interface mode, the user has to tie the RESET pin permanently HIGH. (SDATA and SEN are used as parallel pin controls in this mode)<br>The pin has an internal 100-kΩ pull-down resistor. | I        | 30                    | 1              |

## PIN CONFIGURATION (LVDS MODE) (continued)

### PIN ASSIGNMENTS – LVDS Mode (continued)

| PIN NAME  | DESCRIPTION                                                                                                                                                                                                                                                                                                | PIN TYPE | PIN NUMBER | NUMBER OF PINS |
|-----------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|------------|----------------|
| SCLK      | This pin functions as serial interface clock input when RESET is low. It functions as LOW SPEED control pin when RESET is tied high. Tie SCLK to LOW for $F_s > 50$ MSPS and SCLK to HIGH for $F_s \leq 50$ MSPS. See <a href="#">Table 3</a> . The pin has an internal 100-k $\Omega$ pull-down resistor. | I        | 29         | 1              |
| SDATA     | This pin functions as serial interface data input when RESET is low. It functions as STANDBY control pin when RESET is tied high. See <a href="#">Table 4</a> for detailed information. The pin has an internal 100 k $\Omega$ pull-down resistor.                                                         | I        | 28         | 1              |
| SEN       | This pin functions as serial interface enable input when RESET is low. It functions as CLKOUT edge programmability when RESET is tied high. See <a href="#">Table 5</a> for detailed information. The pin has an internal 100-k $\Omega$ pull-up resistor to DRVDD.                                        | I        | 27         | 1              |
| OE        | Output buffer enable input, active high. The pin has an internal 100-k $\Omega$ pull-up resistor to DRVDD.                                                                                                                                                                                                 | I        | 7          | 1              |
| DFS       | Data Format Select input. This pin sets the DATA FORMAT (Twos complement or Offset binary) and the LVDS/CMOS output mode type. See <a href="#">Table 6</a> for detailed information.                                                                                                                       | I        | 6          | 1              |
| MODE      | Mode select input. This pin selects the Internal or External reference mode. See <a href="#">Table 7</a> for detailed information.                                                                                                                                                                         | I        | 23         | 1              |
| CLKOUTP   | Differential output clock, true                                                                                                                                                                                                                                                                            | O        | 5          | 1              |
| CLKOUTM   | Differential output clock, complement                                                                                                                                                                                                                                                                      | O        | 4          | 1              |
| D0_D1_P   | Differential output data D0 and D1 multiplexed, true                                                                                                                                                                                                                                                       | O        | 34         | 1              |
| D0_D1_M   | Differential output data D0 and D1 multiplexed, complement                                                                                                                                                                                                                                                 | O        | 33         | 1              |
| D2_D3_P   | Differential output data D2 and D3 multiplexed, true                                                                                                                                                                                                                                                       | O        | 38         | 1              |
| D2_D3_M   | Differential output data D2 and D3 multiplexed, complement                                                                                                                                                                                                                                                 | O        | 37         | 1              |
| D4_D5_P   | Differential output data D4 and D5 multiplexed, true                                                                                                                                                                                                                                                       | O        | 40         | 1              |
| D4_D5_M   | Differential output data D4 and D5 multiplexed, complement                                                                                                                                                                                                                                                 | O        | 39         | 1              |
| D6_D7_P   | Differential output data D6 and D7 multiplexed, true                                                                                                                                                                                                                                                       | O        | 42         | 1              |
| D6_D7_M   | Differential output data D6 and D7 multiplexed, complement                                                                                                                                                                                                                                                 | O        | 41         | 1              |
| D8_D9_P   | Differential output data D8 and D9 multiplexed, true                                                                                                                                                                                                                                                       | O        | 44         | 1              |
| D8_D9_M   | Differential output data D8 and D9 multiplexed, complement                                                                                                                                                                                                                                                 | O        | 43         | 1              |
| D10_D11_P | Differential output data D10 and D11 multiplexed, true                                                                                                                                                                                                                                                     | O        | 46         | 1              |
| D10_D11_M | Differential output data D10 and D11 multiplexed, complement                                                                                                                                                                                                                                               | O        | 45         | 1              |
| D12_D13_P | Differential output data D12 and D13 multiplexed, true                                                                                                                                                                                                                                                     | O        | 48         | 1              |
| D12_D13_M | Differential output data D12 and D13 multiplexed, complement                                                                                                                                                                                                                                               | O        | 47         | 1              |
| OVR       | Out-of-range indicator, CMOS level signal                                                                                                                                                                                                                                                                  | O        | 3          | 1              |
| DRVDD     | Digital and output buffer supply                                                                                                                                                                                                                                                                           | I        | 2, 35      | 2              |
| DRGND     | Digital and output buffer ground                                                                                                                                                                                                                                                                           | I        | 1, 36      | 2              |
| NC        | Do not connect                                                                                                                                                                                                                                                                                             |          | 31, 32     | 2              |
| PAD       | For best thermal performance, solder the pad to the ground plane on the board using multiple vias. See <a href="#">Board Design Considerations</a> for details.                                                                                                                                            |          | 0          | 1              |

**PIN CONFIGURATION (CMOS MODE)****Figure 8. CMOS Mode Pinout****PIN ASSIGNMENTS – CMOS Mode**

| PIN NAME   | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                                                                                                                                        | PIN TYPE | PIN NUMBER            | NUMBER OF PINS |
|------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|-----------------------|----------------|
| AVDD       | Analog power supply                                                                                                                                                                                                                                                                                                                                                                                                                                                                | I        | 8, 18, 20, 22, 24, 26 | 6              |
| AGND       | Analog ground                                                                                                                                                                                                                                                                                                                                                                                                                                                                      | I        | 9, 12, 14, 17, 19, 25 | 6              |
| CLKP, CLKM | Differential clock input                                                                                                                                                                                                                                                                                                                                                                                                                                                           | I        | 10, 11                | 2              |
| INP, INM   | Differential analog input                                                                                                                                                                                                                                                                                                                                                                                                                                                          | I        | 15, 16                | 2              |
| VCM        | Internal reference mode – Common-mode voltage output.<br>External reference mode – Reference input. The voltage forced on this pin sets the internal references.                                                                                                                                                                                                                                                                                                                   | I/O      | 13                    | 1              |
| IREF       | Current-set resistor, 56.2-k $\Omega$ resistor to ground.                                                                                                                                                                                                                                                                                                                                                                                                                          | I        | 21                    | 1              |
| RESET      | Serial interface RESET input.<br>When using the serial interface mode, the user MUST initialize internal registers through hardware RESET by applying a high-going pulse on this pin, or by using the software reset option. See the <i>SERIAL INTERFACE</i> section.<br>In parallel interface mode, the user has to tie RESET pin permanently HIGH. (SDATA and SEN are used as parallel pin controls in this mode).<br>The pin has an internal 100-k $\Omega$ pull-down resistor. | I        | 30                    | 1              |
| SCLK       | This pin functions as serial interface clock input when RESET is low.<br>It functions as LOW SPEED control pin when RESET is tied high. Tie SCLK to LOW for $F_s > 50$ MSPS and SCLK to HIGH for $F_s \leq 50$ MSPS. See <a href="#">Table 3</a> .<br>The pin has an internal 100-k $\Omega$ pull-down resistor.                                                                                                                                                                   | I        | 29                    | 1              |



## PIN CONFIGURATION (CMOS MODE) (continued)

### PIN ASSIGNMENTS – CMOS Mode (continued)

| PIN NAME | DESCRIPTION                                                                                                                                                                                                                                                            | PIN TYPE | PIN NUMBER | NUMBER OF PINS |
|----------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|------------|----------------|
| SDATA    | This pin functions as serial interface data input when RESET is low. It functions as STANDBY control pin when RESET is tied high.<br>See <a href="#">Table 4</a> for detailed information.<br>The pin has an internal 100 k $\Omega$ pull-down resistor.               | I        | 28         | 1              |
| SEN      | This pin functions as serial interface enable input when RESET is low. It functions as CLKOUT edge programmability when RESET is tied high. See <a href="#">Table 5</a> for detailed information.<br>The pin has an internal 100-k $\Omega$ pull-up resistor to DRVDD. | I        | 27         | 1              |
| OE       | Output buffer enable input, active high. The pin has an internal 100-k $\Omega$ pull-up resistor to DRVDD.                                                                                                                                                             | I        | 7          | 1              |
| DFS      | Data Format Select input. This pin sets the DATA FORMAT (Twos complement or Offset binary) and the LVDS/CMOS output mode type. See <a href="#">Table 6</a> for detailed information.                                                                                   | I        | 6          | 1              |
| MODE     | Mode select input. This pin selects the internal or external reference mode. See <a href="#">Table 7</a> for detailed information.                                                                                                                                     | I        | 23         | 1              |
| CLKOUT   | CMOS output clock                                                                                                                                                                                                                                                      | O        | 5          | 1              |
| D0       | CMOS output data D0                                                                                                                                                                                                                                                    | O        | 33         | 1              |
| D0       | CMOS output data D1                                                                                                                                                                                                                                                    | O        | 34         | 1              |
| D2       | CMOS output data D2                                                                                                                                                                                                                                                    | O        | 37         | 1              |
| D2       | CMOS output data D3                                                                                                                                                                                                                                                    | O        | 38         | 1              |
| D4       | CMOS output data D4                                                                                                                                                                                                                                                    | O        | 39         | 1              |
| D4       | CMOS output data D5                                                                                                                                                                                                                                                    | O        | 40         | 1              |
| D6       | CMOS output data D6                                                                                                                                                                                                                                                    | O        | 41         | 1              |
| D7       | CMOS output data D7                                                                                                                                                                                                                                                    | O        | 42         | 1              |
| D8       | CMOS output data D8                                                                                                                                                                                                                                                    | O        | 43         | 1              |
| D9       | CMOS output data D9                                                                                                                                                                                                                                                    | O        | 44         | 1              |
| D10      | CMOS output data D10                                                                                                                                                                                                                                                   | O        | 45         | 1              |
| D11      | CMOS output data D11                                                                                                                                                                                                                                                   | O        | 46         | 1              |
| D12      | CMOS output data D12                                                                                                                                                                                                                                                   | O        | 47         | 1              |
| D13      | CMOS output data D13                                                                                                                                                                                                                                                   | O        | 48         | 1              |
| OVR      | Out-of-range indicator, CMOS level signal                                                                                                                                                                                                                              | O        | 3          | 1              |
| DRVDD    | Digital and output buffer supply                                                                                                                                                                                                                                       | I        | 2, 35      | 2              |
| DRGND    | Digital and output buffer ground                                                                                                                                                                                                                                       | I        | 1, 36      | 2              |
| UNUSED   | Unused pin in CMOS mode                                                                                                                                                                                                                                                |          | 4          | 1              |
| NC       | Do not connect                                                                                                                                                                                                                                                         |          | 31, 32     | 2              |
| PAD      | For best thermal performance, solder the pad to the ground plane on the board using multiple vias. See <a href="#">Board Design Considerations</a> for details.                                                                                                        |          | 0          | 1              |

## TYPICAL CHARACTERISTICS

All plots are at 25°C, AVDD = DRVDD = 3.3 V, sampling frequency = 170 MSPS, sine wave input clock, 1.5 V<sub>pp</sub> differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0 dB gain, DDR LVDS data output (unless otherwise noted)

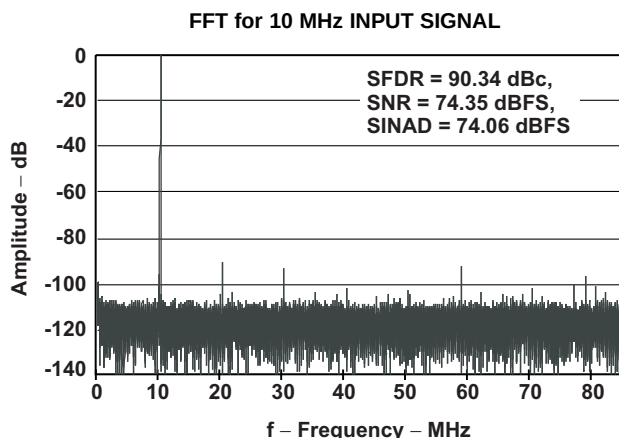


Figure 9.

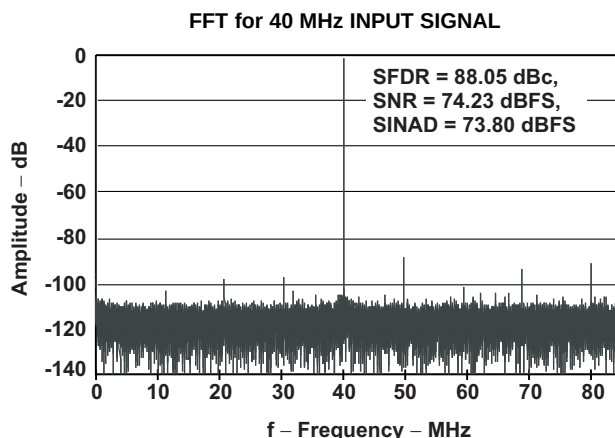


Figure 10.

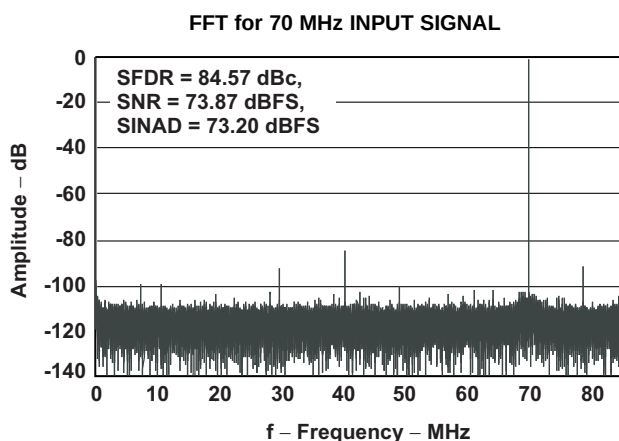


Figure 11.

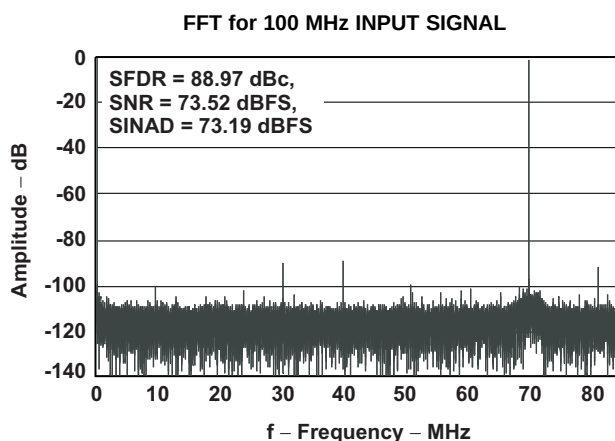


Figure 12.

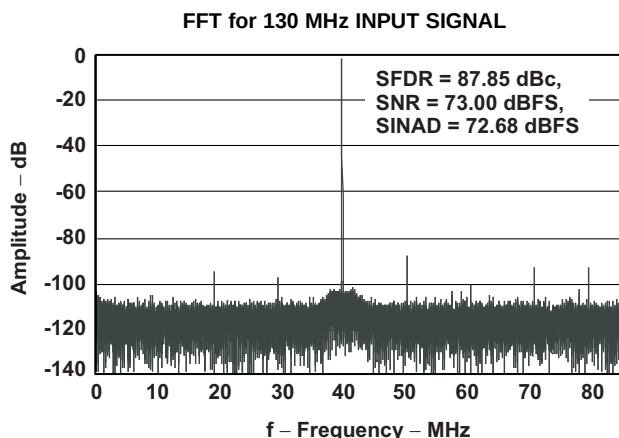


Figure 13.

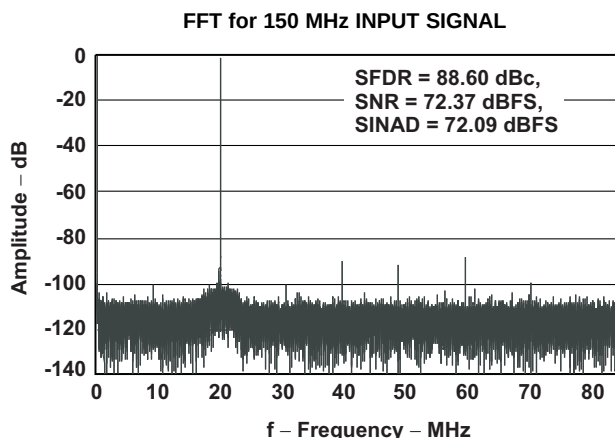


Figure 14.

## TYPICAL CHARACTERISTICS (continued)

All plots are at 25°C, AVDD = DRVDD = 3.3 V, sampling frequency = 170 MSPS, sine wave input clock, 1.5 V<sub>pp</sub> differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0 dB gain, DDR LVDS data output (unless otherwise noted)

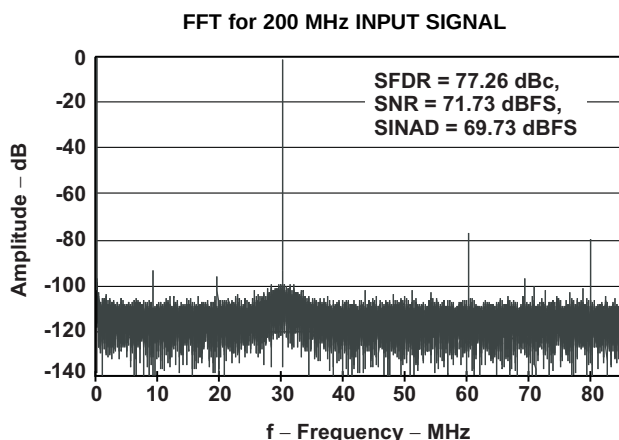


Figure 15.

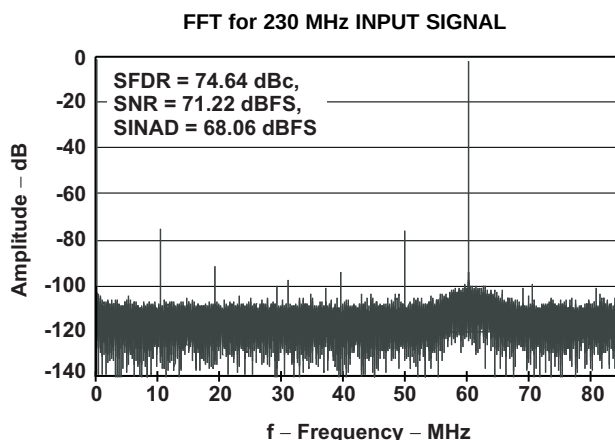


Figure 16.

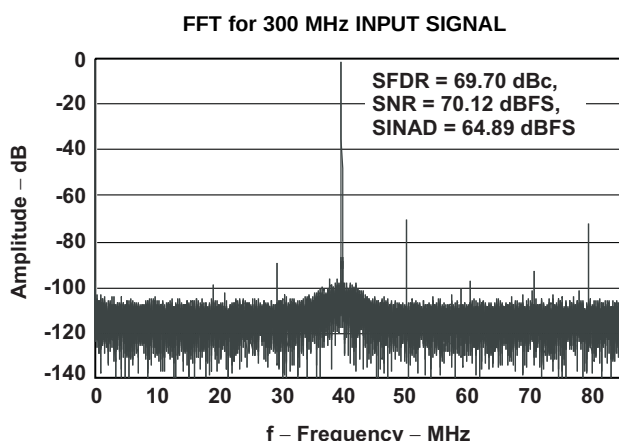


Figure 17.

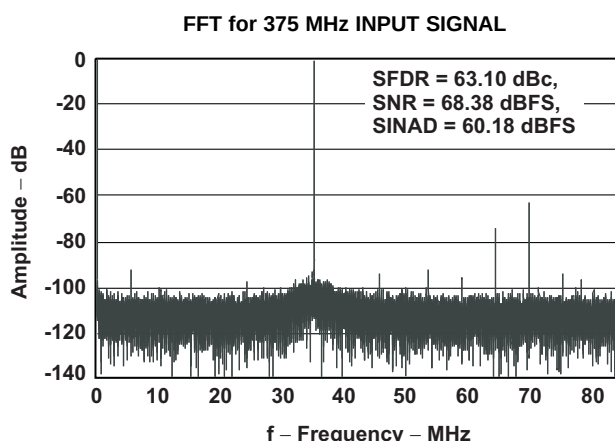


Figure 18.

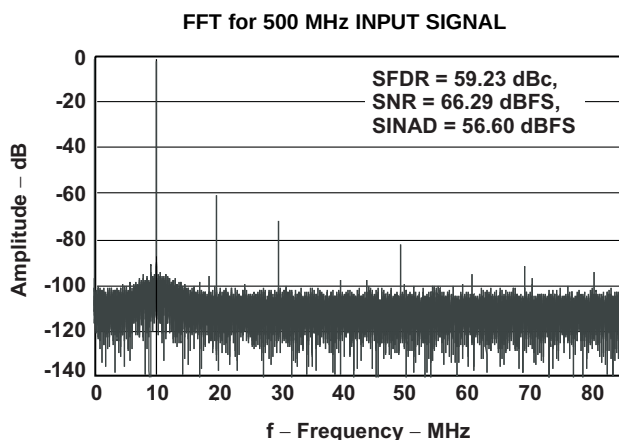


Figure 19.

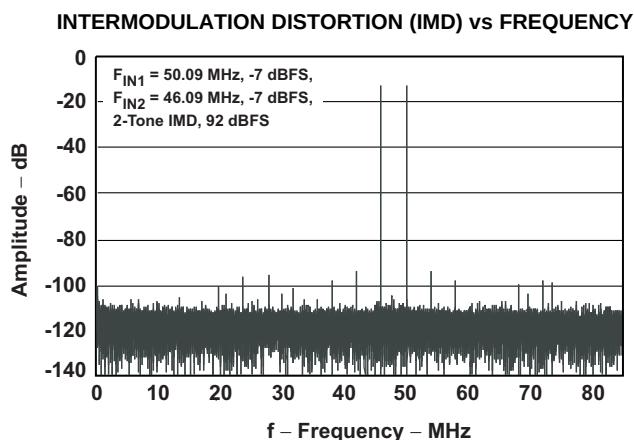


Figure 20.

## TYPICAL CHARACTERISTICS (continued)

All plots are at 25°C, AVDD = DRVDD = 3.3 V, sampling frequency = 170 MSPS, sine wave input clock, 1.5 V<sub>pp</sub> differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0 dB gain, DDR LVDS data output (unless otherwise noted)

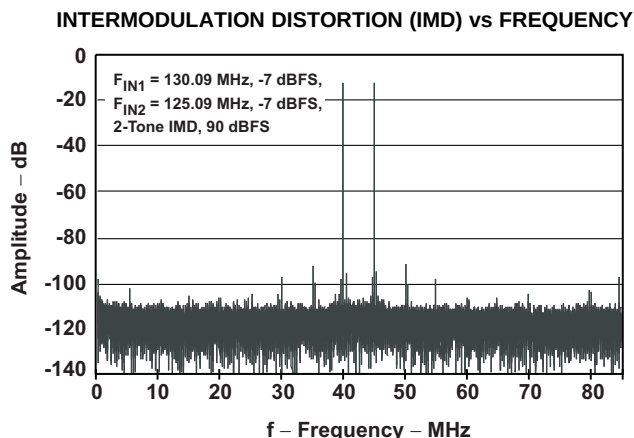


Figure 21.

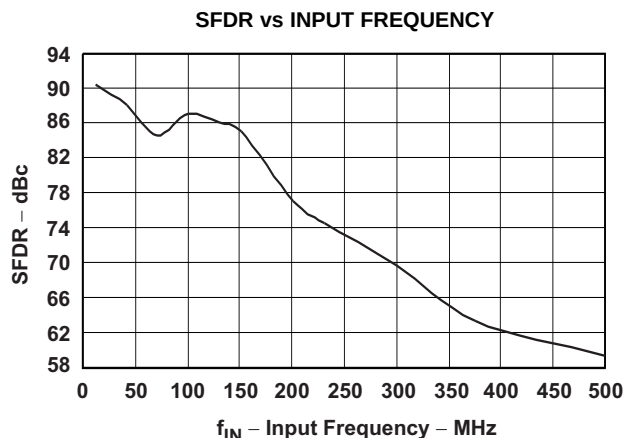


Figure 22.

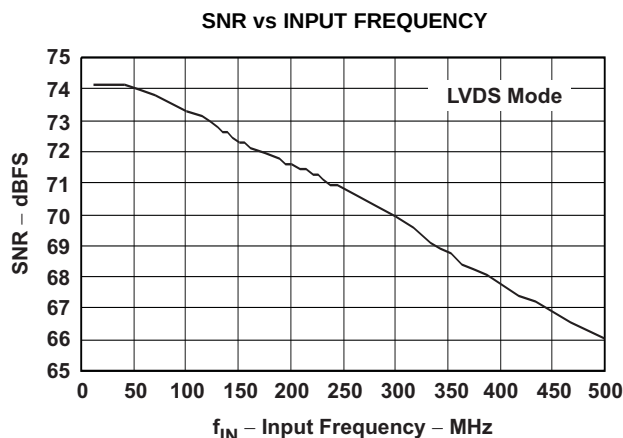


Figure 23.

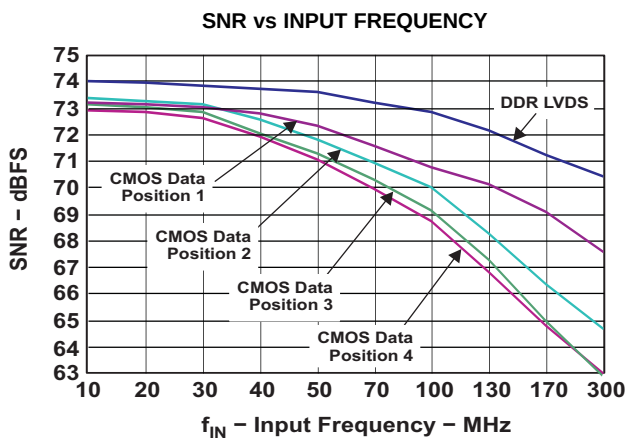


Figure 24.

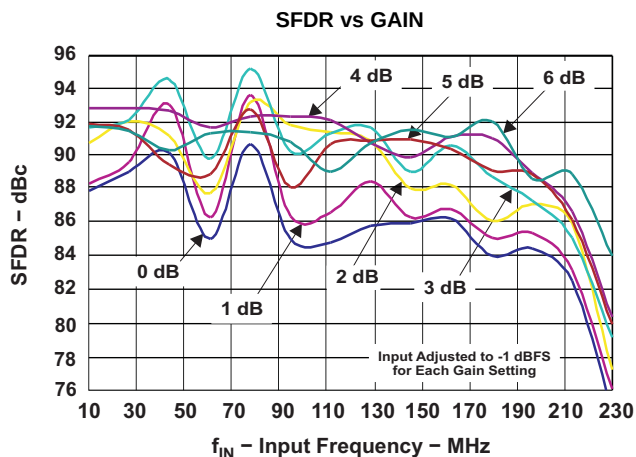


Figure 25.

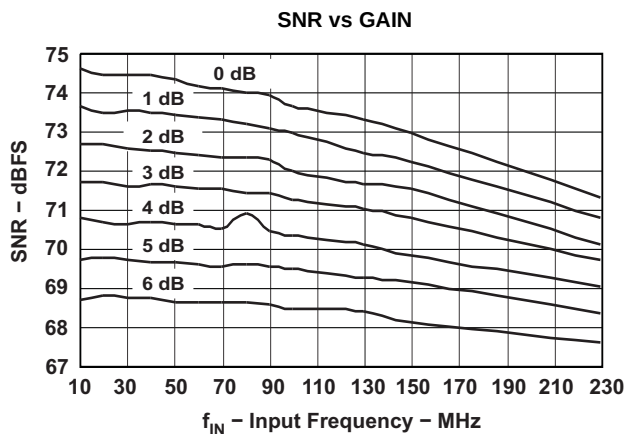


Figure 26.

## TYPICAL CHARACTERISTICS (continued)

All plots are at 25°C, AVDD = DRVDD = 3.3 V, sampling frequency = 170 MSPS, sine wave input clock, 1.5 V<sub>PP</sub> differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0 dB gain, DDR LVDS data output (unless otherwise noted)

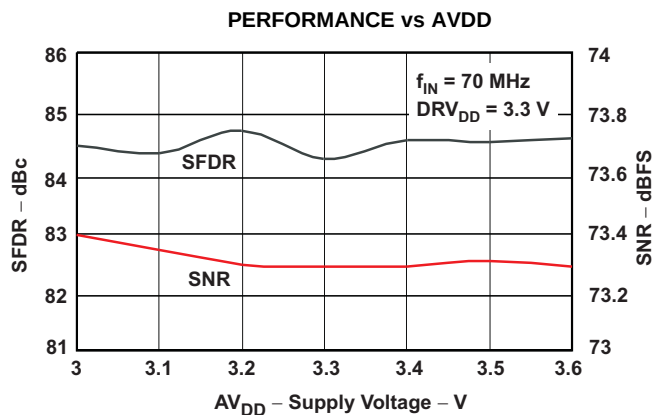


Figure 27.

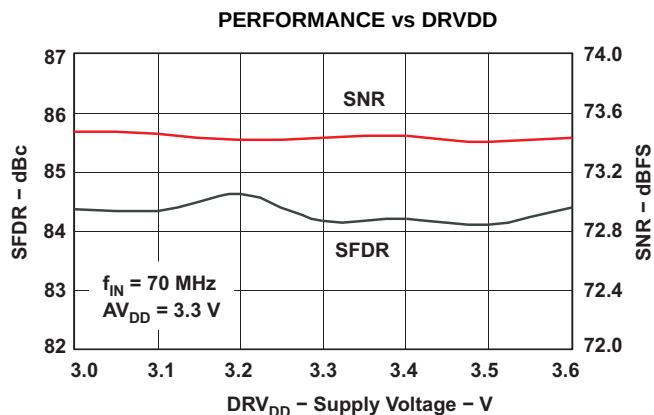


Figure 28.

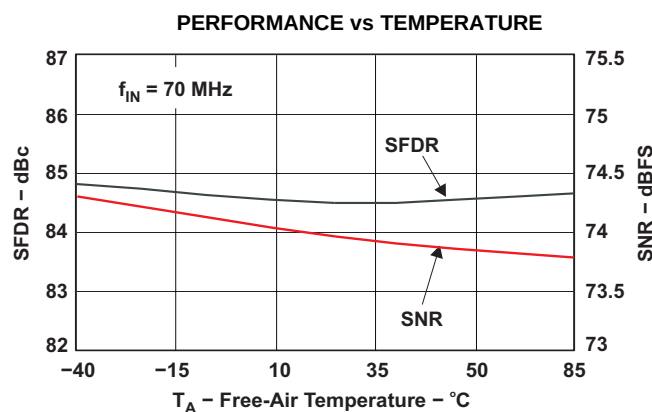


Figure 29.

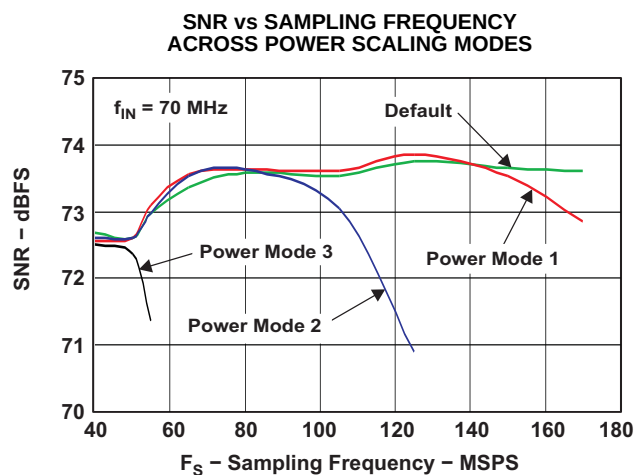


Figure 30.

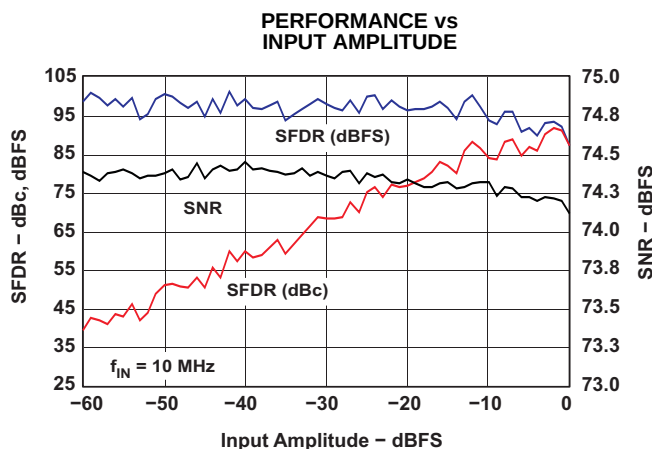


Figure 31.

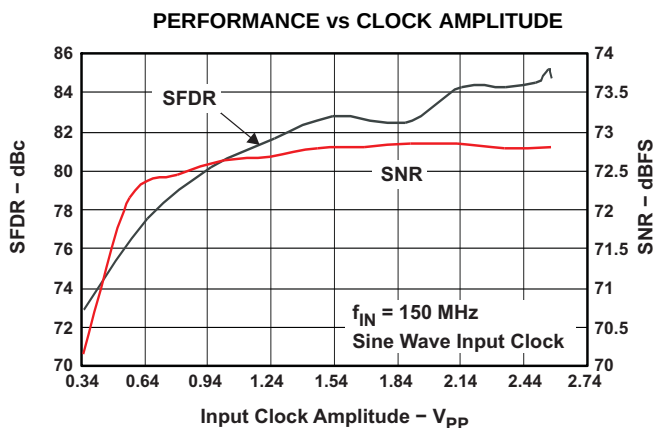


Figure 32.

## TYPICAL CHARACTERISTICS (continued)

All plots are at 25°C, AVDD = DRVDD = 3.3 V, sampling frequency = 170 MSPS, sine wave input clock, 1.5 V<sub>pp</sub> differential clock amplitude, 50% clock duty cycle, –1 dBFS differential analog input, internal reference mode, 0 dB gain, DDR LVDS data output (unless otherwise noted)

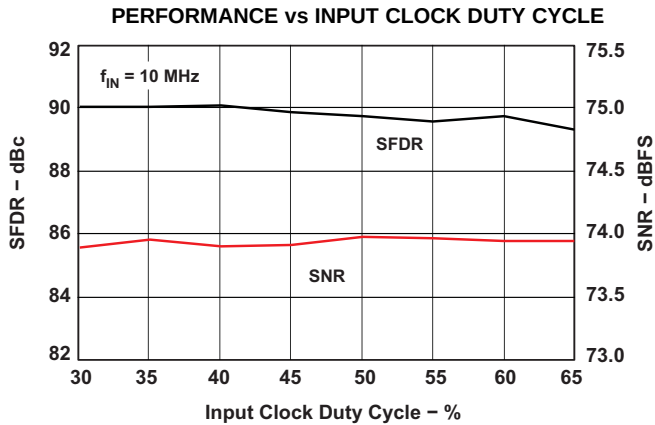


Figure 33.

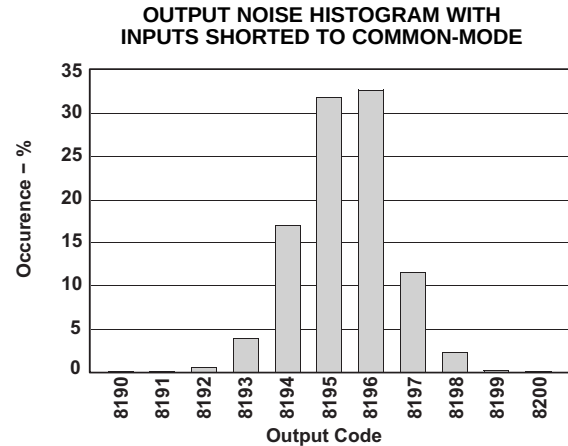


Figure 34.

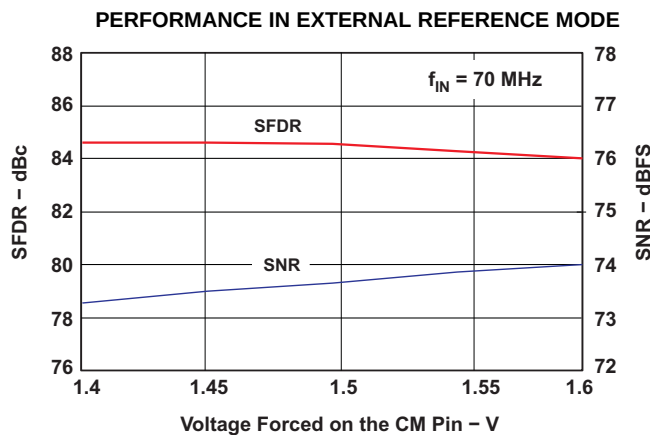


Figure 35.

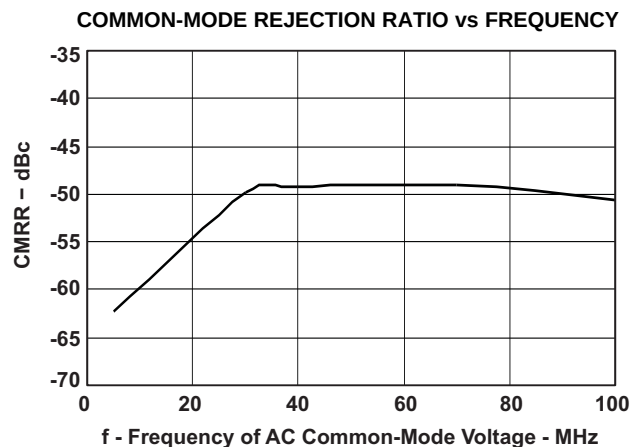


Figure 36.

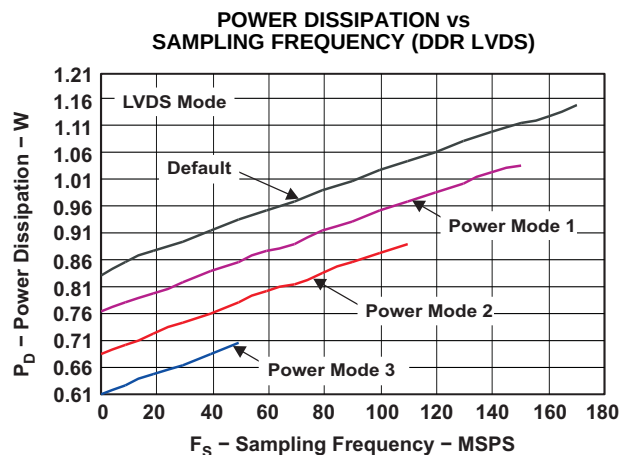


Figure 37.

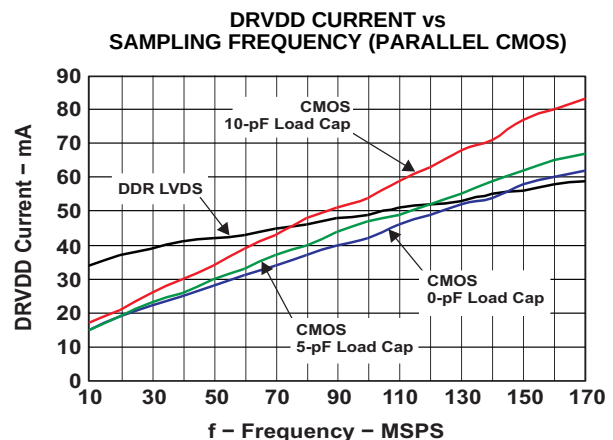


Figure 38.

### TYPICAL CHARACTERISTICS (continued)

All plots are at 25°C, AVDD = DRVDD = 3.3 V, sampling frequency = 170 MSPS, sine wave input clock, 1.5 V<sub>pp</sub> differential clock amplitude, 50% clock duty cycle, -1 dBFS differential analog input, internal reference mode, 0 dB gain, DDR LVDS data output (unless otherwise noted)

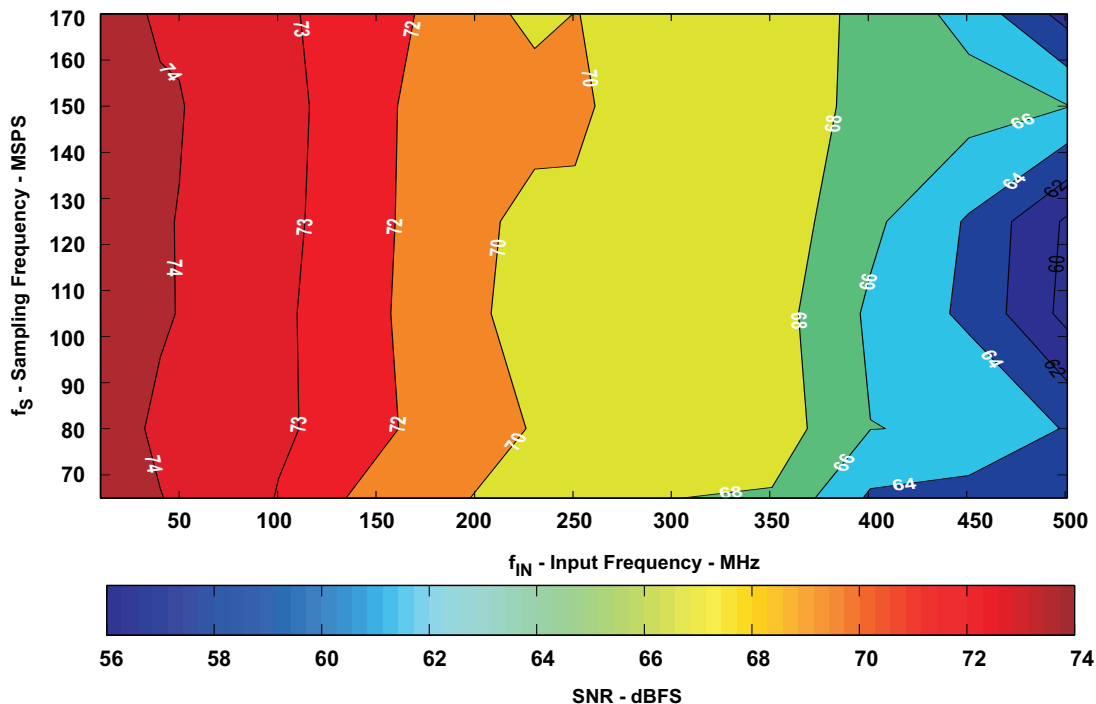


Figure 39. SNR Contour in dBFS

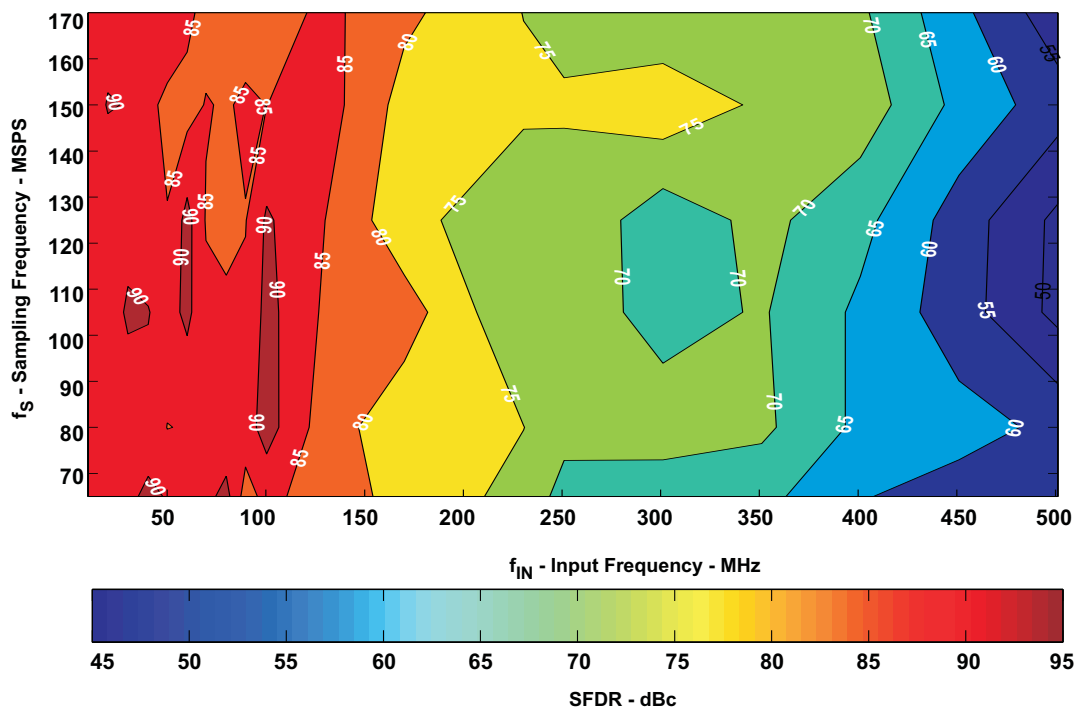


Figure 40. SFDR Contour in dBc

## APPLICATION INFORMATION

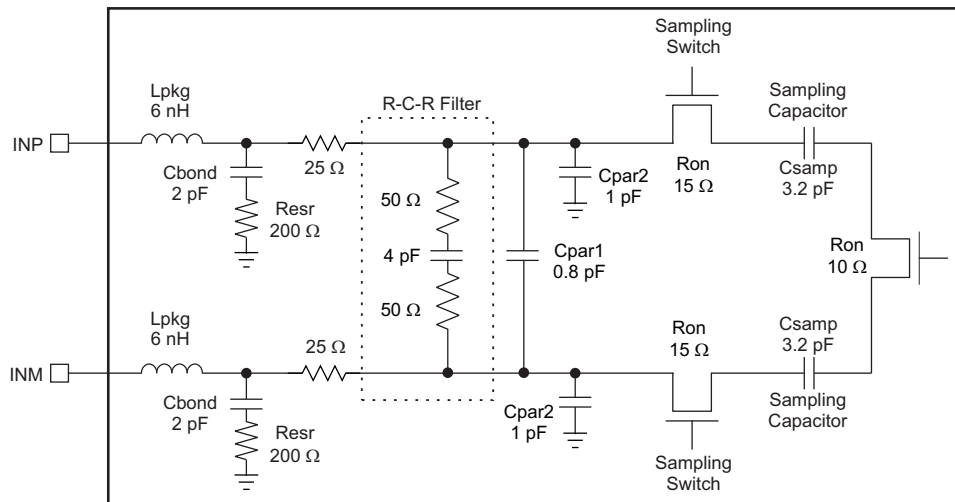
### THEORY OF OPERATION

ADS5545 is a low power 14-bit 170 MSPS pipeline ADC in a CMOS process. ADS5545 is based on switched capacitor technology and runs off a single 3.3-V supply. The conversion process is initiated by a rising edge of the external input clock. Once the signal is captured by the input sample and hold, the input sample is sequentially converted by a series of lower resolution stages, with the outputs combined in a digital correction logic block. At every clock edge, the sample propagates through the pipeline resulting in a data latency of 14 clock cycles. The output is available as 14-bit data, in DDR LVDS or CMOS and coded in either straight offset binary or binary 2's complement format.

### ANALOG INPUT

The analog input consists of a switched-capacitor based differential sample and hold architecture, shown in Figure 41.

This differential topology results in good ac-performance even for high input frequencies at high sampling rates. The INP and INM pins have to be externally biased around a common-mode voltage of 1.5 V, available on VCM pin 13. For a full-scale differential input, each input pin (INP, INM) has to swing symmetrically between  $V_{CM} + 0.5\text{ V}$  and  $V_{CM} - 0.5\text{ V}$ , resulting in a  $2\text{-}V_{PP}$  differential input swing. The maximum swing is determined by the internal reference voltages REFP (2.5 V nominal) and REFM (0.5 V, nominal).



**Figure 41. Input Stage**

The input sampling circuit has a 3-dB bandwidth that extends up to 500 MHz, see Figure 42, (measured from the input pins to the voltage across the sampling capacitors).



## APPLICATION INFORMATION (continued)

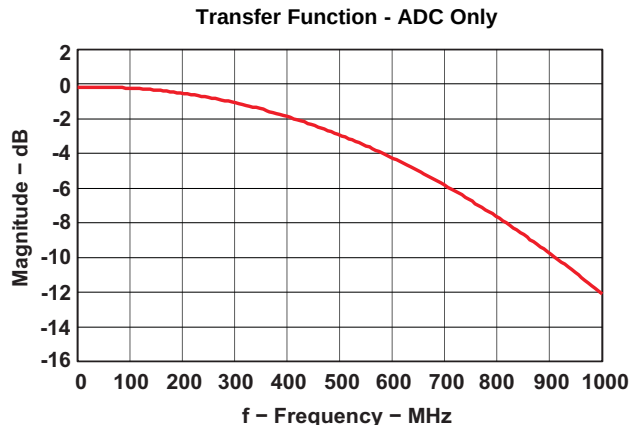


Figure 42. Analog Input Bandwidth  
(Data From Actual Silicon)

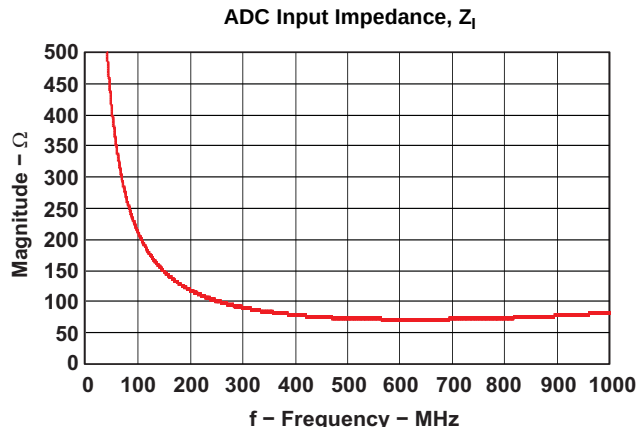


Figure 43. Impedance Looking Into INP, INM  
(Data From Simulation)

### Driving Circuit

A 5- $\Omega$  resistor in series with each input pin is recommended to damp out ringing caused by the package parasitics. It is also necessary to present a low impedance (< 50  $\Omega$ ) for the common-mode switching currents. For example, this is achieved by using two resistors from each input terminated to the common-mode voltage (VCM).

In addition to the above ADC requirements, the drive circuit may have to be designed to provide a low insertion loss over the desired frequency range and matched impedance to the source. For this, the ADC input impedance has to be considered, see [Figure 43](#).

### Example Drive Circuits

A configuration suitable for low input frequency ranges (< 100 MHz) is shown in [Figure 44](#). Note the 5- $\Omega$  series resistors and the low common-mode impedance (using 25- $\Omega$  resistors terminated to VCM). In addition, the circuit has low insertion loss, and good impedance match at low input frequencies, see [Figure 45](#).

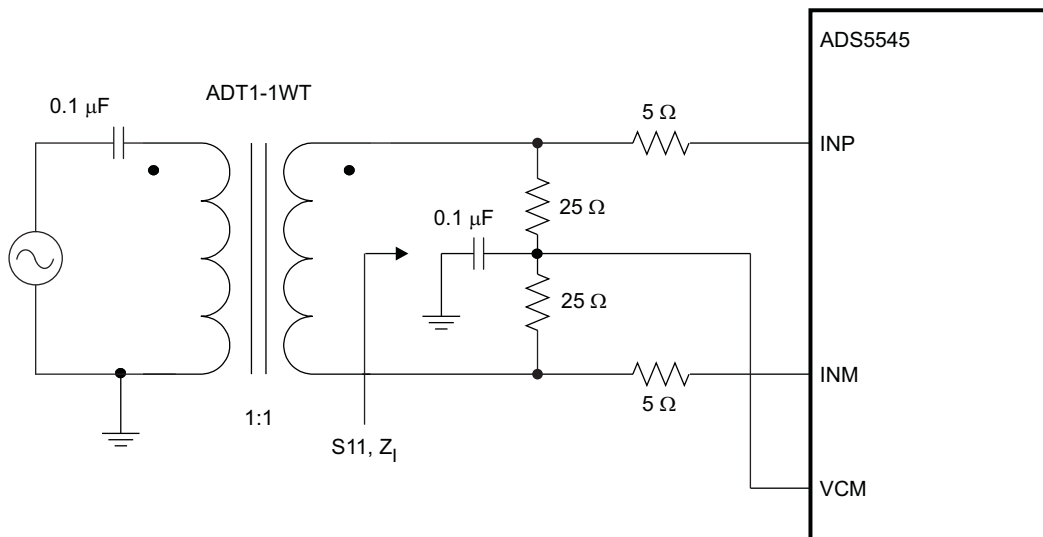
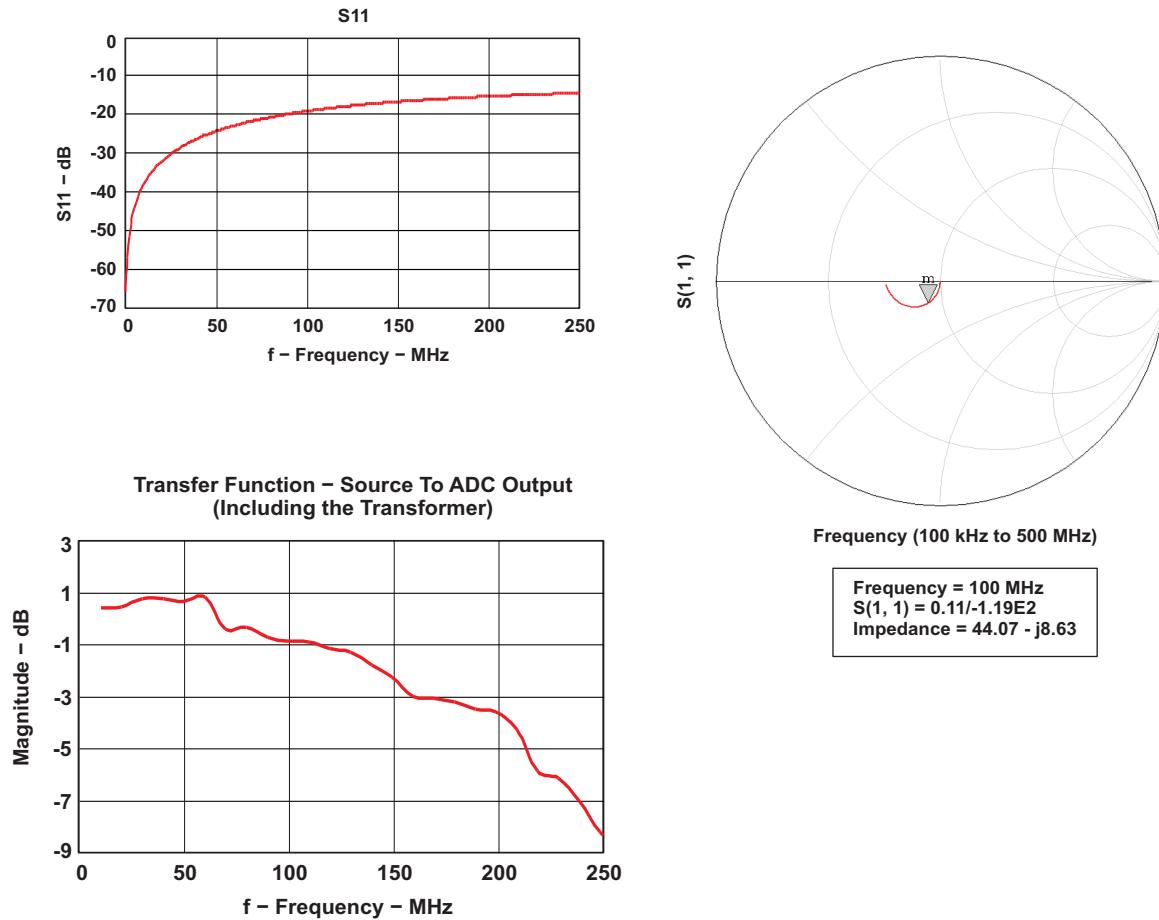
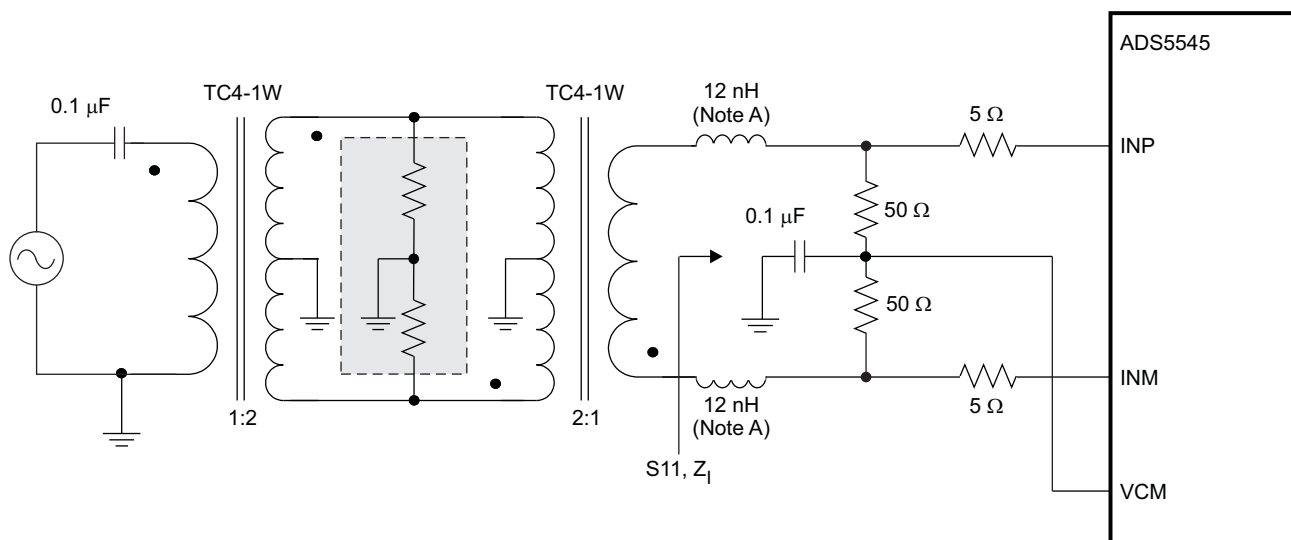


Figure 44. Drive Circuit at Low Input Frequencies

**APPLICATION INFORMATION (continued)****Figure 45. S11, Input Impedance and Transfer Function for the Configuration in [Figure 44](#)**

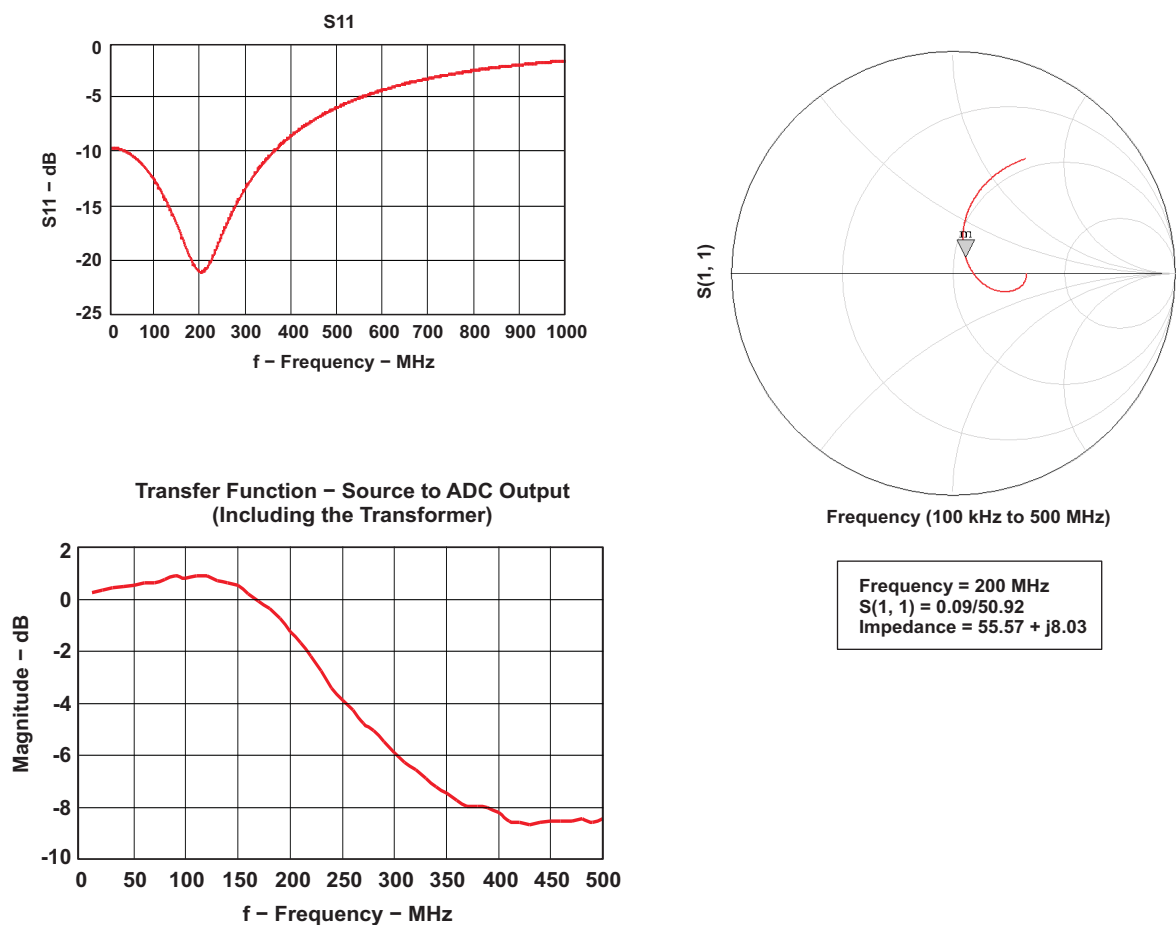
For high input frequencies, the previous configuration has been modified to improve the insertion loss and impedance matching (see [Figure 46](#)). The S11 curve shows that the matching is good from 100 MHz to 300 MHz.

# APPLICATION INFORMATION (continued)



A. Includes transformer leakage inductances.

**Figure 46. Configuration for High Input Frequencies**



**Figure 47. S11, Input Impedance and Transfer Function for the Configuration in Figure 46**

## APPLICATION INFORMATION (continued)

### Using RF Transformer-Based Drive Circuits

For optimum performance, the analog inputs must be driven differentially. This improves the common-mode noise immunity and even order harmonic rejection. Some examples of input configurations using RF transformers suitable for low and high input frequencies are shown in [Figure 46](#) and [Figure 47](#).

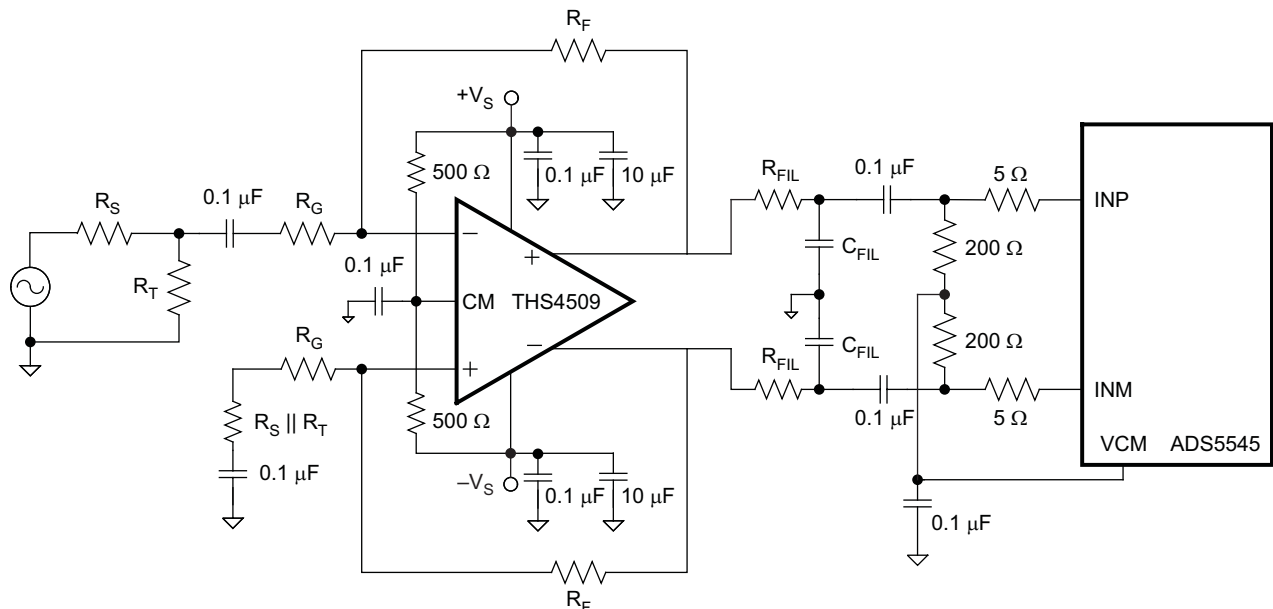
The single-ended signal is fed to the primary winding of the RF transformer. The transformer is terminated on the secondary side. Putting the termination on the secondary side helps to shield the kickbacks caused by the sampling circuit from the RF transformer's leakage inductances. The termination is accomplished by two resistors connected in series, with the center point connected to the 1.5 V common-mode (VCM pin 13). The value of the termination resistors (connected to common-mode) has to be low ( $< 100 \Omega$ ) to provide a low-impedance path for the ADC common-mode switching current.

At high input frequencies, the mismatch in the transformer parasitic capacitance (between the windings) results in degraded even-order harmonic performance. Connecting two identical RF transformers back-to-back helps minimize this mismatch, and good performance is obtained for high frequency input signals. An additional termination resistor pair (enclosed within the shaded box in [Figure 46](#)) may be required between the two transformers to improve the balance between the P and M sides. The center point of this termination must be connected to ground. (Note that the drive circuit has to be tuned to account for this additional termination, to get the desired S11 and impedance match).

### Using Differential Amplifier Drive Circuits

[Figure 48](#) shows a drive circuit using a differential amplifier (THS4509) to convert a single-ended input to differential output that can be interface to the ADC analog input pins. In addition to the single-ended to differential conversion, the amplifier also provides gain (10 dB in [Figure 48](#)).  $R_{FIL}$  helps to isolate the amplifier outputs from the switching input of the ADC. Together with  $C_{FIL}$  it also forms a low-pass filter that band-limits the noise (and signal) at the ADC input. As the amplifier output is ac-coupled, the common-mode voltage of the ADC input pins is set using two  $200 \Omega$  resistors connected to VCM.

The amplifier output can also be dc-coupled. Using the output common-mode control of the THS4509, the ADC input pins can be biased to 1.5 V. In this case, use +4 V and -1 V supplies for the THS4509 so that the output common-mode voltage (1.5V) is at the supply mid-point.



**Figure 48. Drive Circuit Using the THS4509**

See the EVM User Guide ([SLWU028](#)) for more information.

## APPLICATION INFORMATION (continued)

### Input Common-Mode

To ensure a low-noise common-mode reference, the VCM pin is filtered with a 0.1-μF low-inductance capacitor connected to ground. The VCM pin is designed to directly drive the ADC inputs. The input stage of the ADC sinks a common-mode current in the order of 280 μA (at 170 MSPS). Equation 1 describes the dependency of the common-mode current and the sampling frequency.

$$\frac{(280 \mu\text{A}) \times F_s}{170 \text{ MSPS}} \quad (1)$$

This equation helps to design the output capability and impedance of the CM driving circuit accordingly.

### Reference

ADS5545 has built-in internal references REFP and REFM, requiring no external components. Design schemes are used to linearize the converter load seen by the references; this and the integration of the requisite reference capacitors on-chip eliminates the need for external decoupling. The full-scale input range of the converter can be controlled in the external reference mode as explained below. The internal or external reference modes can be selected by controlling the MODE pin 23 (see Table 7 for details) or by programming the serial interface register bit <REF> (Table 16).

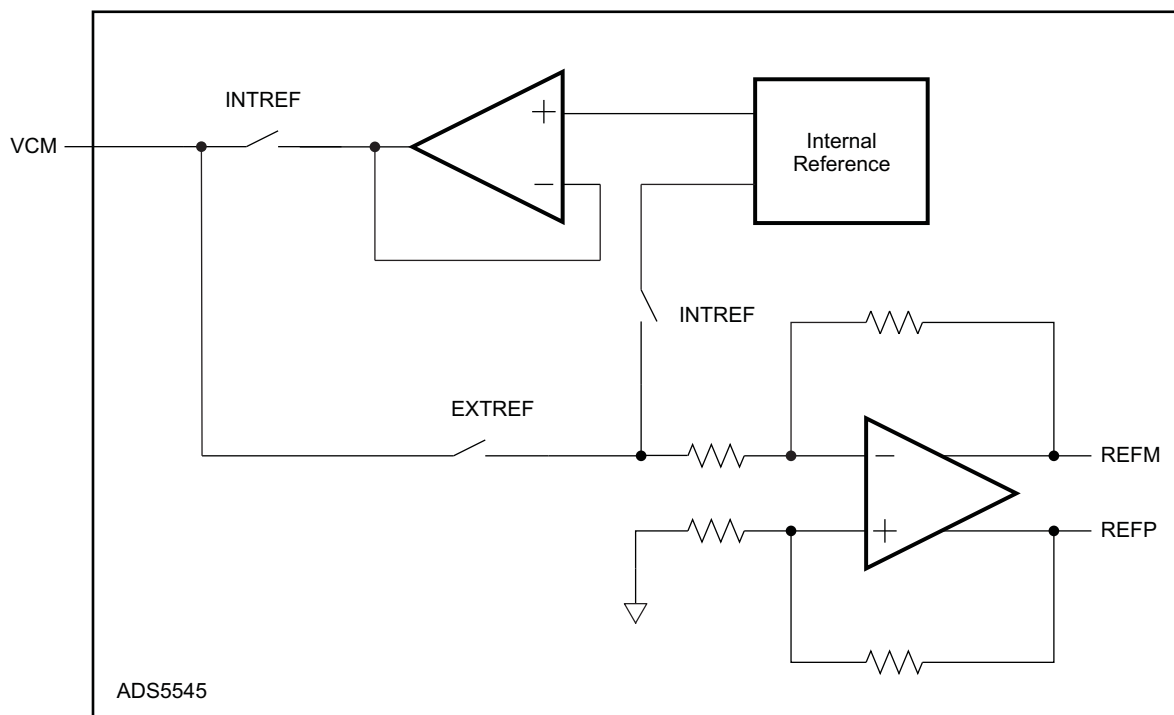


Figure 49. Reference Section

### Internal Reference

When the device is in internal reference mode, the REFP and REFM voltages are generated internally. Common-mode voltage (1.5 V nominal) is output on VCM pin, which can be used to externally bias the analog input pins.

## APPLICATION INFORMATION (continued)

### External Reference

When the device is in external reference mode, the VCM acts as a reference input pin. The voltage forced on the VCM pin is buffered and gained by 1.33 internally, generating the REFP and REFM voltages. The differential input voltage corresponding to full-scale is given by [Equation 2](#).

$$\text{Full-scale differential input pp} = (\text{Voltage forced on VCM}) \times 1.33 \quad (2)$$

In this mode, the 1.5 V common-mode voltage to bias the input pins has to be generated externally. There is no change in performance compared to internal reference mode.

### Low Sampling Frequency Operation

For best performance at high sampling frequencies, ADS5545 uses a clock generator circuit to derive internal timing for the ADC. The clock generator operates from 170 MSPS down to 50 MSPS in the DEFAULT SPEED mode. The ADC enters this mode after applying reset (with serial interface configuration) or by tying SCLK pin to **low** (with parallel configuration).

For low sampling frequencies (below 50 MSPS), the ADC must be put in the LOW SPEED mode. This mode can be entered by:

- setting the register bit **<LOW SPEED>** ([Table 10](#)) through the serial interface, OR
- tying the SCLK pin to **high** ([Table 3](#)) using the parallel configuration.

### Clock Input

ADS5545 clock inputs can be driven differentially (SINE, LVPECL or LVDS) or single-ended (LVCMOS), with little or no difference in performance between configurations. The common-mode voltage of the clock inputs is set to VCM using internal 5-k $\Omega$  resistors as shown in [Figure 50](#). This allows the use of transformer-coupled drive circuits for sine wave clock, or ac-coupling for LVPECL, LVDS clock sources ([Figure 51](#) and [Figure 52](#))

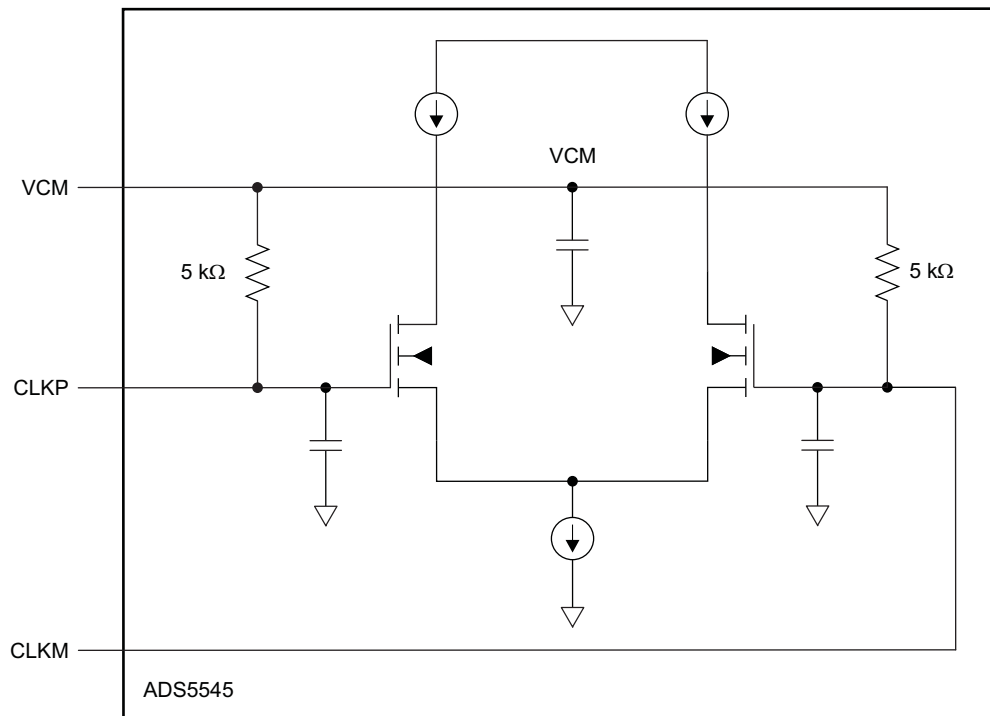
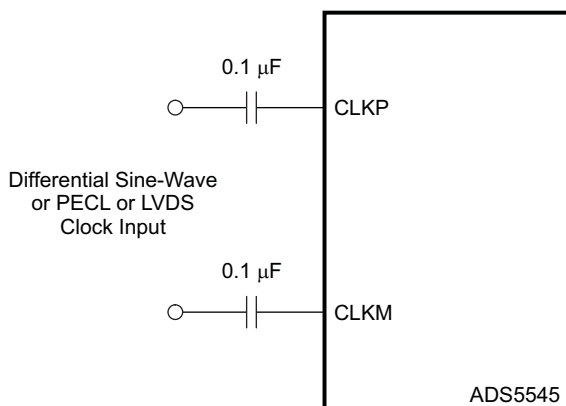


Figure 50. Internal Clock Buffer

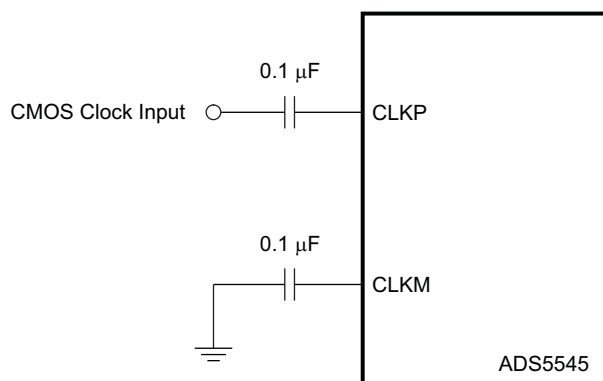
## APPLICATION INFORMATION (continued)

For best performance, it is recommended to drive the clock inputs differentially, reducing susceptibility to common-mode noise. In this case, it is best to connect both clock inputs to the differential input clock signal with 0.1- $\mu$ F capacitors, as in [Figure 51](#).



**Figure 51. Differential Clock Driving Circuit**

A single-ended CMOS clock can be ac-coupled to the CLKP input, with CLKM (pin 11) connected to ground with a 0.1- $\mu$ F capacitor, as in [Figure 52](#).



**Figure 52. Single-Ended Clock Driving Circuit**

For best performance, the clock inputs have to be driven differentially, reducing susceptibility to common-mode noise. For high input frequency sampling, the use a clock source with very low jitter is recommended. Bandpass filtering of the clock source can help reduce the effect of jitter. There is no change in performance with a non-50% duty cycle clock input. [Figure 33](#) shows the performance variation of the ADC versus clock duty cycle

### Input Clock Buffer Gain

When using a sinusoidal clock input, the noise contributed by clock jitter improves as the clock amplitude is increased. Therefore, using a large amplitude clock is recommended. In addition, the clock buffer has a programmable gain option to amplify the input clock. There are 5 gain settings, with Gain 4 being the maximum gain and Gain 0 the minimum gain setting. The default gain is Gain 1. The clock buffer gain can be set by programming the register bits **<CLKIN GAIN>** ([Table 14](#)).

## APPLICATION INFORMATION (continued)

### Programmable Gain

ADS5545 has programmable gain from 0 dB to 6 dB in steps of 1 dB. The corresponding full-scale input range varies from  $2 V_{PP}$  down to  $1 V_{PP}$ , with 0 dB being the default gain. At high IF, this is especially useful as the SFDR improvement is significant with marginal degradation in SNR.

The gain can be programmed using the register bits **<GAIN>** (Table 12).

**Table 19. Full-scale Range Across Gains**

| Gain | Corresponding full-scale range, Vpp |
|------|-------------------------------------|
| 0 dB | 2.00                                |
| 1 dB | 1.78                                |
| 2 dB | 1.59                                |
| 3 dB | 1.42                                |
| 4 dB | 1.26                                |
| 5 dB | 1.12                                |
| 6 dB | 1.00                                |

### Power Down

ADS5545 has three power-down modes – global STANDBY, output buffer disabled, and input clock stopped.

#### Global STANDBY

This mode can be initiated by controlling SDATA (pin 28) or by setting the register bit **<STBY>** (Table 10) through the serial interface. In this mode, the A/D converter, reference block and the output buffers are powered down and the total power dissipation reduces to about 100 mW. The output buffers are in high impedance state. The wake-up time from the global power down to data becoming valid normal mode is maximum 100  $\mu$ s.

#### Output Buffer Disable

The output buffers can be disabled using OE pin 7 in both the LVDS and CMOS modes, reducing the total power by about 100 mW. With the buffers disabled, the outputs are in high impedance state. The wake-up time from this mode to data becoming valid in normal mode is maximum 1  $\mu$ s in LVDS mode and 50 ns in CMOS mode.

#### Input Clock Stop

The converter enters this mode when the input clock frequency falls below 1 MSPS. The power dissipation is about 100 mW and the wake-up time from this mode to data becoming valid in normal mode is maximum 100  $\mu$ s.



## Power Scaling Modes

ADS5545 has a power scaling mode in which the device can be operated at reduced power levels at lower sampling frequencies with no difference in performance. (Figure 30)<sup>(1)</sup> There are four power scaling modes for different sampling frequency ranges which can be programmed using the serial interface register bits **<SCALING>** (see Table 16). Only the AVDD power is scaled, leaving the DRVDD power unchanged.

**Table 20. Power Scaling vs Sampling Speed**

| Sampling Frequency<br>MSPS | Power Scaling Mode | Analog Power<br>(Typical) | Analog Power in Default Mode |
|----------------------------|--------------------|---------------------------|------------------------------|
| > 150                      | Default            | 928 mW at 170 MSPS        | 928 mW at 170 MSPS           |
| 105 to 150                 | Power Mode 1       | 841 mW at 150 MSPS        | 917 mW at 150 MSPS           |
| 50 to 105                  | Power Mode 2       | 670 mW at 105 MSPS        | 830 mW at 105 MSPS           |
| < 50                       | Power Mode 3       | 525 mW at 50 MSPS         | 760 mW at 50 MSPS            |

(1) The performance in the power scaling modes is from characterization and not tested in production.

## Power Supply Sequence

During power-up, the AVDD and DRVDD supplies can come up in any sequence. The two supplies are separated inside the device. Externally, they can be driven from separate supplies or from a single supply.

## Digital Output Information

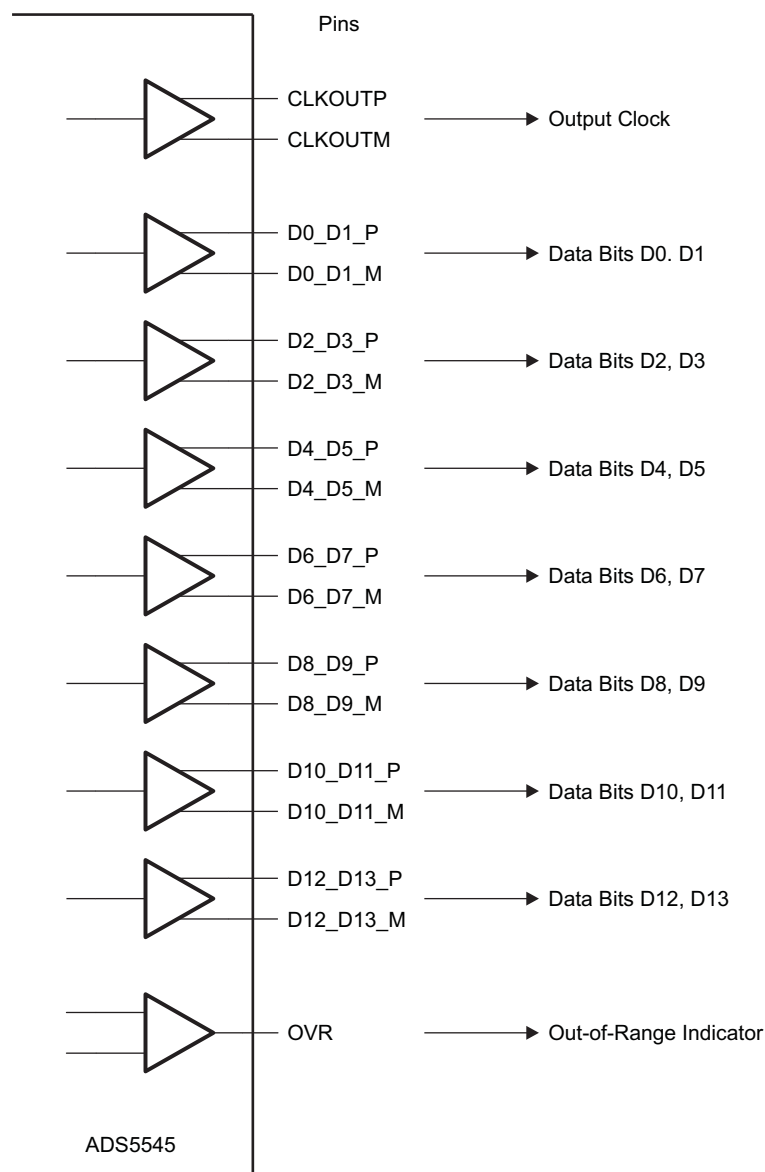
ADS5545 provides 14-bit data, an output clock synchronized with the data and an out-of-range indicator that goes high when the output reaches the full-scale limits. In addition, output enable control (OE pin 7) is provided to power down the output buffers and put the outputs in high-impedance state.

## Output Interface

Two output interface options are available – Double Data Rate (DDR) LVDS and parallel CMOS. They can be selected using the DFS (Table 6) or the serial interface register bit **<ODI>** (Table 15).

## DDR LVDS Outputs

In this mode, the 14 data bits and the output clock are available as LVDS (Low Voltage Differential Signal) levels. Two successive data bits are multiplexed and output on each LVDS differential pair as shown in Figure 53. So, there are 7 LVDS output pairs for the 14 data bits and 1 LVDS output pair for the output clock.

**Figure 53. DDR LVDS Outputs**

Even data bits D0, D2, D4, D6, D8, D10, and D12 are output at the falling edge of CLKOUTP and the odd data bits D1, D3, D5, D7, D9, D11, and D13 are output at the rising edge of CLKOUTP. Both the rising and falling edges of CLKOUTP have to be used to capture all the 14 data bits ([Figure 54](#)).

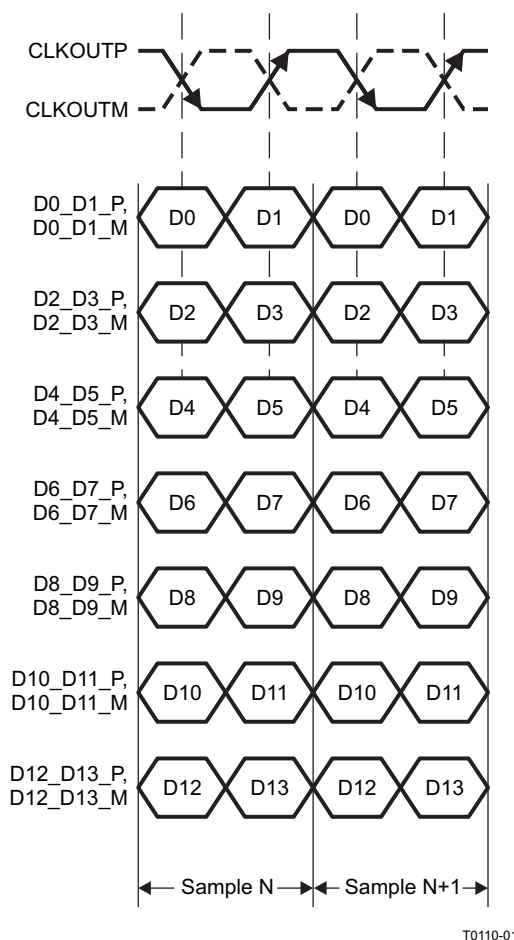


Figure 54. DDR LVDS Interface

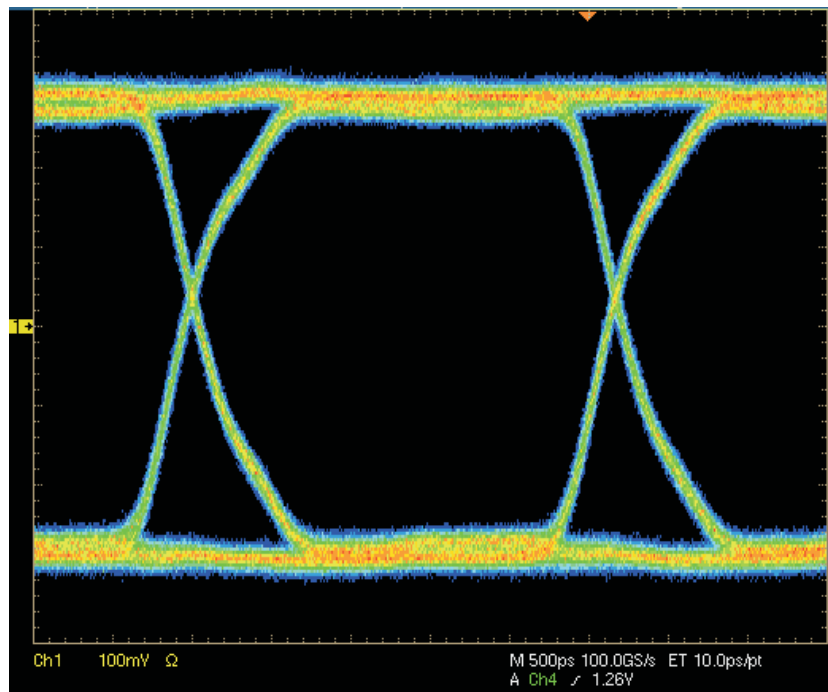
### LVDS Buffer Current Programmability

The default LVDS buffer output current is 3.5 mA. When terminated by 100  $\Omega$ , this results in a 350-mV single-ended voltage swing (700-mV<sub>PP</sub> differential swing). The LVDS buffer currents can also be programmed to 2.5 mA, 4.5 mA, and 1.75 mA using the register bits <LVDS CURR> (Table 17). In addition, there exists a current double mode, where this current is doubled for the data and output clock buffers (register bits <CURR DOUBLE>) (Table 18).

### LVDS Buffer Internal Termination

An internal termination option is available (using the serial interface), by which the LVDS buffers are differentially terminated inside the device. The termination resistances available are – 325, 200, and 170  $\Omega$  (nominal with  $\pm 20\%$  variation). Any combination of these three terminations can be programmed; the effective termination is the parallel combination of the selected resistances. This results in eight effective terminations from open (no termination) to 75  $\Omega$ .

The internal termination helps to absorb any reflections coming from the receiver end, improving the signal integrity. With 100- $\Omega$  internal and 100- $\Omega$  external termination, the voltage swing at the receiver end is halved (compared to no internal termination). The voltage swing can be restored by using the LVDS current double mode. Figure 55 shows the eye diagram of one of the LVDS data outputs with a 10-pF load capacitance (from each pin to ground) and 100- $\Omega$  internal termination enabled. The terminations can be programmed using register bits <DATA TERM> and <CLKOUT TERM> (Table 17).



**Figure 55. Eye Diagram of LVDS Data Output With Internal Termination and 10-pF capacitance load**

### Parallel CMOS

In this mode, the 14 data outputs and the output clock are available as 3.3-V CMOS voltage levels. Each data bit and the output clock is available on a separate pin in parallel. By default, the data outputs are valid during the rising edge of the output clock. The output clock is CLKOUT (pin 5).

### CMOS Mode Power Dissipation

With CMOS outputs, the DRVDD current scales with the sampling frequency and the load capacitance on every output pin (see [Figure 38](#)). The maximum DRVDD current occurs when each output bit toggles between 0 and 1 every clock cycle. In actual applications, this condition is unlikely to occur. The actual DRVDD current is determined by the average number of output bits switching, which is a function of the sampling frequency and the nature of the analog input signal.

$$\text{Digital current due to CMOS output switching} = C_L \times V_{\text{DRVDD}} \times (N \times F_{\text{AVG}})$$

where  $C_L$  = load capacitance,  $N \times F_{\text{AVG}}$  = average number of output bits switching

[Figure 38](#) shows the current with various load capacitances across sampling frequencies at 2 MHz analog input frequency.

### Output Switching Noise and Data Position Programmability (in CMOS mode ONLY)

Switching noise (caused by CMOS output data transitions) can couple into the analog inputs during the instant of sampling and degrade the SNR. To minimize this, the device includes programmable options to move the output data transitions with respect to the output clock. This can be used to position the data transitions at the optimum place away from the sampling instant and improve the SNR. [Figure 24](#) shows the variation of SNR for different CMOS output data positions at 190 MSPS.

Note that the optimum output data position varies with the sampling frequency. The data position can be programmed using the register bits <DATA POSN> ([Table 9](#)).

It is recommended to put series resistors (50 to 100  $\Omega$ ) on each output line placed very close to the converter pins. This helps to isolate the outputs from seeing large load capacitances and in turn reduces the amount of switching noise. For example, the data in [Figure 24](#) was taken with 50  $\Omega$  series resistors on each output line.

## Output Clock Position Programmability

In both the LVDS and CMOS modes, the output clock can be moved around its default position. This can be done using SEN pin 27 (as described in [Table 5](#)) or using the register bits **<CLKOUT POSN>** ([Table 9](#)). Using this allows to trade-off the setup and hold times leading to reliable data capture. There also exists an option to align the output clock edge with the data transition.

Note that programming the output clock position also affects the clock propagation delay times.

## Output Data Format

Two output data formats are supported – 2's complement and offset binary. They can be selected using the DFS (pin 6) or the serial interface register bit **<DF>** ([Table 10](#)).

## Out-of-range Indicator (OVR)

When the input voltage exceeds the full-scale range of the ADC, OVR (pin 3) goes high, and the output code is clamped to the appropriate full-scale level for the duration of the overload. For a positive overdrive, the output code is 0x3FFF in offset binary output format, and 0x1FFF in 2's complement output format. For a negative input overdrive, the output code is 0x0000 in offset binary output format and 0x2000 in 2's complement output format. [Figure 56](#) shows the behavior of OVR during the overload. Note that OVR and the output code react to the overload after a latency of 14 clock cycles.

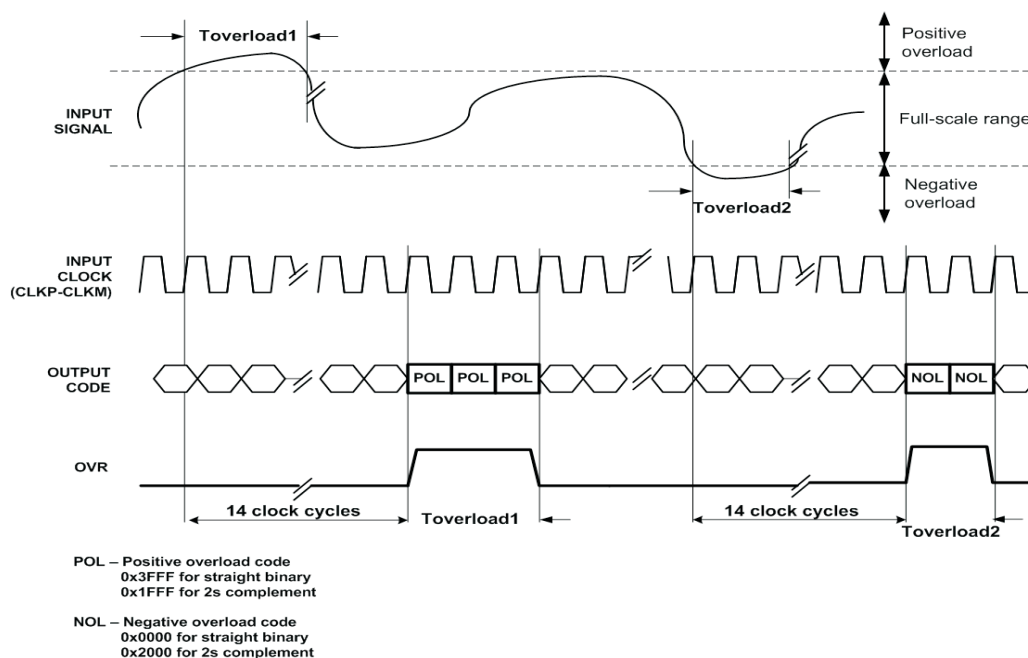


Figure 56. OVR During Input Overvoltage

## Output Timing

For the best performance at high sampling frequencies, ADS5545 uses a clock generator circuit to derive internal timing for ADC. This results in optimal setup and hold times of the output data and 50% output clock duty cycle for sampling frequencies from 80 MSPS to 170 MSPS. See [Table 21](#) for timing information above 80 MSPS.

**Table 21. Timing Characteristics (80 MSPS to 170 MSPS) <sup>(1)</sup>**

| Fs, MSPS             | t <sub>SU</sub> DATA SETUP TIME, ns <sup>(2)</sup> |     |     | t <sub>H</sub> DATA HOLD TIME, ns <sup>(2)</sup> |     |     | t <sub>PDI</sub> CLOCK PROPAGATION DELAY, ns <sup>(3)</sup> |     |      |
|----------------------|----------------------------------------------------|-----|-----|--------------------------------------------------|-----|-----|-------------------------------------------------------------|-----|------|
|                      | MIN                                                | TYP | MAX | MIN                                              | TYP | MAX | MIN                                                         | TYP | MAX  |
| <b>DDR LVDS</b>      |                                                    |     |     |                                                  |     |     |                                                             |     |      |
| 150                  | 1.6                                                | 2.1 |     | 0.6                                              | 1.1 |     | 4.3                                                         | 5   | 5.7  |
| 130                  | 2.0                                                | 2.5 |     | 0.8                                              | 1.3 |     | 4.5                                                         | 5.2 | 5.9  |
| 80                   | 3.6                                                | 4.1 |     | 1.6                                              | 2.1 |     | 4.7                                                         | 5.7 | 6.7  |
| <b>PARALLEL CMOS</b> |                                                    |     |     |                                                  |     |     |                                                             |     |      |
| 150                  | 2.8                                                | 3.6 |     | 1.2                                              | 1.6 |     | 1.7                                                         | 2.5 | 3.3  |
| 130                  | 3.3                                                | 4.1 |     | 1.7                                              | 2.1 |     | 1.1                                                         | 1.9 | 2.7  |
| 80                   | 6                                                  | 7   |     | 3.7                                              | 4.1 |     | 10.8                                                        | 12  | 13.2 |

- (1) Timing parameters are specified by design and characterization and not tested in production.  
 (2) Setup and hold times are specified with default output clock and data positions. For other positions, the timing numbers have to be adjusted appropriately.  
 (3) Clock propagation delay timings are specified with default output clock positions. For other positions, the timing numbers have to be adjusted appropriately.

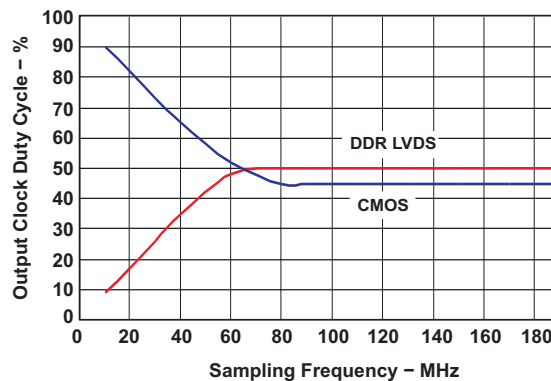
Below 80 MSPS, the setup and hold times do not scale with the sampling frequency. The output clock duty cycle also progressively moves away from 50% as the sampling frequency is reduced from 80 MSPS.

See [Table 22](#) for detailed timings at sampling frequencies below 80 MSPS. [Figure 57](#) shows the clock duty cycle across sampling frequencies in the DDR LVDS and CMOS modes.

**Table 22. Timing Characteristics (1 MSPS to 80 MSPS) <sup>(1)</sup>**

| Fs, MSPS             | t <sub>SU</sub> DATA SETUP TIME, ns <sup>(2)</sup> |     |     | t <sub>H</sub> DATA HOLD TIME, ns <sup>(2)</sup> |     |     | t <sub>PDI</sub> CLOCK PROPAGATION DELAY, ns <sup>(3)</sup> |     |     |
|----------------------|----------------------------------------------------|-----|-----|--------------------------------------------------|-----|-----|-------------------------------------------------------------|-----|-----|
|                      | MIN                                                | TYP | MAX | MIN                                              | TYP | MAX | MIN                                                         | TYP | MAX |
| <b>DDR LVDS</b>      |                                                    |     |     |                                                  |     |     |                                                             |     |     |
| 1 to 80              | 3.6                                                |     |     | 1.6                                              |     |     |                                                             | 5.7 |     |
| <b>PARALLEL CMOS</b> |                                                    |     |     |                                                  |     |     |                                                             |     |     |
| 1 to 80              | 6                                                  |     |     | 3.7                                              |     |     |                                                             | 12  |     |

- (1) Timing parameters are specified by design and characterization and not tested in production.  
 (2) Setup and hold times are specified with default output clock and data positions. For other positions, the timing numbers have to be adjusted appropriately.  
 (3) Clock propagation delay timings are specified with default output clock positions. For other positions, the timing numbers have to be adjusted appropriately.

**Figure 57. Output Clock Duty Cycle (typical) vs Sampling Frequency**

The latency of ADS5545 is 14 clock cycles from the sampling instant (input clock rising edge). In the LVDS mode, the latency remains constant across sampling frequencies. In the CMOS mode, the latency is 14 clock cycles above 80 MSPS and 13 clock cycles below 80 MSPS.

## Board Design Considerations

### Grounding

A single ground plane is sufficient to give good performance, provided the analog, digital and clock sections of the board are cleanly partitioned. See the EVM User Guide ([SLWU028](#)) for details on layout and grounding.

### Supply Decoupling

As the ADS5546 already includes internal decoupling, minimal external decoupling can be used without loss in performance. Note that decoupling capacitors can help to filter external power supply noise, so the optimum number of capacitors would depend on the actual application. The decoupling capacitors should be placed very close to the converter supply pins.

It is recommended to use separate supplies for the analog and digital supply pins to isolate digital switching noise from sensitive analog circuitry. In case only a single 3.3-V supply is available, it should be routed first to AVDD. It can then be tapped and isolated with a ferrite bead (or inductor) with decoupling capacitor, before being routed to DRVDD.

### Series Resistors on Data Outputs

It is recommended to put series resistors (50 to 100  $\Omega$ ) on each output line placed very close to the converter pins. This helps to isolate the outputs from seeing large load capacitances and in turn reduces the amount of switching noise.

### Exposed Thermal Pad

For best thermal performance, it is necessary to solder the exposed pad at the bottom of the package to a ground plane using multiple vias. For detailed information, see application notes **QFN Layout Guidelines** ([SLOA122](#)) and **QFN/SON PCB Attachment** ([SLUA271](#)).

## DEFINITION OF SPECIFICATIONS

### Analog Bandwidth

The analog input frequency at which the power of the fundamental is reduced by 3 dB with respect to the low frequency value.

### Aperture Delay

The delay in time between the rising edge of the input sampling clock and the actual time at which the sampling occurs.

### Aperture Uncertainty (Jitter)

The sample-to-sample variation in aperture delay.

### Clock Pulse Width/Duty Cycle

The duty cycle of a clock signal is the ratio of the time the clock signal remains at a logic high (clock pulse width) to the period of the clock signal. Duty cycle is typically expressed as a percentage. A perfect differential sine-wave clock results in a 50% duty cycle.

### Maximum Conversion Rate

The maximum sampling rate at which certified operation is given. All parametric testing is performed at this sampling rate unless otherwise noted.

### Minimum Conversion Rate

The minimum sampling rate at which the ADC functions.

### Differential Nonlinearity (DNL)

An ideal ADC exhibits code transitions at analog input values spaced exactly 1 LSB apart. The DNL is the deviation of any single step from this ideal value, measured in units of LSBs

### Integral Nonlinearity (INL)

The INL is the deviation of the ADC's transfer function from a best fit line determined by a least squares curve fit of that transfer function, measured in units of LSBs.

### Gain Error

The gain error is the deviation of the ADC's actual input full-scale range from its ideal value. The gain error is given as a percentage of the ideal input full-scale range.

### Offset Error

The offset error is the difference, given in number of LSBs, between the ADC's actual average idle channel output code and the ideal average idle channel output code. This quantity is often mapped into mV.

### Temperature Drift

The temperature drift coefficient (with respect to gain error and offset error) specifies the change per degree Celsius of the parameter from  $T_{\text{MIN}}$  to  $T_{\text{MAX}}$ . It is calculated by dividing the maximum deviation of the parameter across the  $T_{\text{MIN}}$  to  $T_{\text{MAX}}$  range by the difference  $T_{\text{MAX}} - T_{\text{MIN}}$ .



## DEFINITION OF SPECIFICATIONS (continued)

### Signal-to-Noise Ratio

SNR is the ratio of the power of the fundamental ( $P_S$ ) to the noise floor power ( $P_N$ ), excluding the power at dc and the first nine harmonics.

$$\text{SNR} = 10\log_{10} \frac{P_S}{P_N} \quad (4)$$

SNR is either given in units of dBc (dB to carrier) when the absolute power of the fundamental is used as the reference, or dBFS (dB to full scale) when the power of the fundamental is extrapolated to the converter's full-scale range.

### Signal-to-Noise and Distortion (SINAD)

SINAD is the ratio of the power of the fundamental ( $P_S$ ) to the power of all the other spectral components including noise ( $P_N$ ) and distortion ( $P_D$ ), but excluding dc.

$$\text{SINAD} = 10\log_{10} \frac{P_S}{P_N + P_D} \quad (5)$$

SINAD is either given in units of dBc (dB to carrier) when the absolute power of the fundamental is used as the reference, or dBFS (dB to full scale) when the power of the fundamental is extrapolated to the converter's full-scale range.

### Effective Number of Bits (ENOB)

The ENOB is a measure of a converter's performance as compared to the theoretical limit based on quantization noise.

$$\text{ENOB} = \frac{\text{SINAD} - 1.76}{6.02} \quad (6)$$

### Total Harmonic Distortion (THD)

THD is the ratio of the power of the fundamental ( $P_S$ ) to the power of the first nine harmonics ( $P_D$ ).

$$\text{THD} = 10\log_{10} \frac{P_S}{P_D} \quad (7)$$

THD is typically given in units of dBc (dB to carrier).

### Spurious-Free Dynamic Range (SFDR)

The ratio of the power of the fundamental to the highest other spectral component (either spur or harmonic). SFDR is typically given in units of dBc (dB to carrier).

### Two-Tone Intermodulation Distortion

IMD3 is the ratio of the power of the fundamental (at frequencies  $f_1$  and  $f_2$ ) to the power of the worst spectral component at either frequency  $2f_1 - f_2$  or  $2f_2 - f_1$ . IMD3 is either given in units of dBc (dB to carrier) when the absolute power of the fundamental is used as the reference, or dBFS (dB to full scale) when the power of the fundamental is extrapolated to the converter's full-scale range.

### DC Power Supply Rejection Ratio (DC PSRR)

The DC PSRR is the ratio of the change in offset error to a change in analog supply voltage. The DC PSRR is typically given in units of mV/V.

**DEFINITION OF SPECIFICATIONS (continued)****AC Power Supply Rejection Ratio (AC PSRR)**

AC PSRR is the measure of rejection of variations in the supply voltage of the ADC. If  $\Delta V_{SUP}$  is the change in the supply voltage and  $\Delta V_{OUT}$  is the resultant change in the ADC output code (referred to the input), then

$$PSRR = 20\text{Log}^{10} \frac{\Delta V_{OUT}}{\Delta V_{SUP}} \quad (\text{Expressed in dBc}) \quad (8)$$

**Common Mode Rejection Ratio (CMRR)**

CMRR is the measure of rejection of variations in the input common-mode voltage of the ADC. If  $\Delta V_{cm}$  is the change in the input common-mode voltage and  $\Delta V_{OUT}$  is the resultant change in the ADC output code (referred to the input), then

$$CMRR = 20\text{Log}^{10} \frac{\Delta V_{OUT}}{\Delta V_{CM}} \quad (\text{Expressed in dBc}) \quad (9)$$

**Voltage Overload Recovery**

The number of clock cycles taken to recover to less than 1% error for a 6-dB overload on the analog inputs. A 6-dBFS sine wave at Nyquist frequency is used as the test stimulus.

### ADS5545 Revision history

| Revision | Date  | Description                                                                                 |
|----------|-------|---------------------------------------------------------------------------------------------|
| A        | 03/06 | Added new graphs to the Typical Characteristics. Added the Application Information section. |
| B        | 09/06 | New Timing Characteristics table. Revised the Application Information section.              |
|          |       | New text for the Device Mode Configuration.                                                 |
|          |       | Parallel Pin Control section changed to Parallel Configuration Only section.                |
|          |       | Added Serial Interface Configuration Only section.                                          |
|          |       | Added Configuration using Both the Serial Interface and Parallel Controls.                  |
|          |       | New text for the Serial Interface section                                                   |
|          |       | Added Register Reset section.                                                               |
|          |       | Additions to <RST> and <GAIN>.                                                              |
|          |       | Revised Typical Characteristics graphs.                                                     |
|          |       | Added Programmable gain section in the Application Information                              |
| C        | 04/07 | Added thermal pad to <a href="#">Figure 7</a> and <a href="#">Figure 8</a> .                |
|          |       | Added Graph DRVDD Current ( <a href="#">Figure 38</a> ).                                    |
|          |       | Changed the Application Information section and figures.                                    |
|          |       | Changed Drive Circuit and Example Drive Circuit information and figures.                    |
|          |       | Added Using RF Transformer-Based Drive Circuits information                                 |
|          |       | Added Using Differential Amplifier Drive Circuits information.                              |
|          |       | Added CMOS Mode Power Dissipation                                                           |
|          |       | Added <i>Overvoltage Signal</i> information and <a href="#">Figure 56</a> .                 |
|          |       | Added Output Data Position Programmability section                                          |
|          |       | Added min/max specifications for offset error and gain error.                               |
|          |       | Changed the Serial Register tables. Changed <a href="#">Figure 24</a>                       |

**PACKAGING INFORMATION**

| Orderable Device | Status <sup>(1)</sup> | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <sup>(2)</sup> | Lead/Ball Finish | MSL Peak Temp <sup>(3)</sup> |
|------------------|-----------------------|--------------|-----------------|------|-------------|-------------------------|------------------|------------------------------|
| ADS5545IRGZ25    | ACTIVE                | VQFN         | RGZ             | 48   | 25          | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-3-260C-168 HR          |
| ADS5545IRGZR     | ACTIVE                | VQFN         | RGZ             | 48   | 2500        | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-3-260C-168 HR          |
| ADS5545IRGZRG4   | ACTIVE                | VQFN         | RGZ             | 48   | 2500        | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-3-260C-168 HR          |
| ADS5545IRGZT     | ACTIVE                | VQFN         | RGZ             | 48   | 250         | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-3-260C-168 HR          |
| ADS5545IRGZTG4   | ACTIVE                | VQFN         | RGZ             | 48   | 250         | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-3-260C-168 HR          |

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

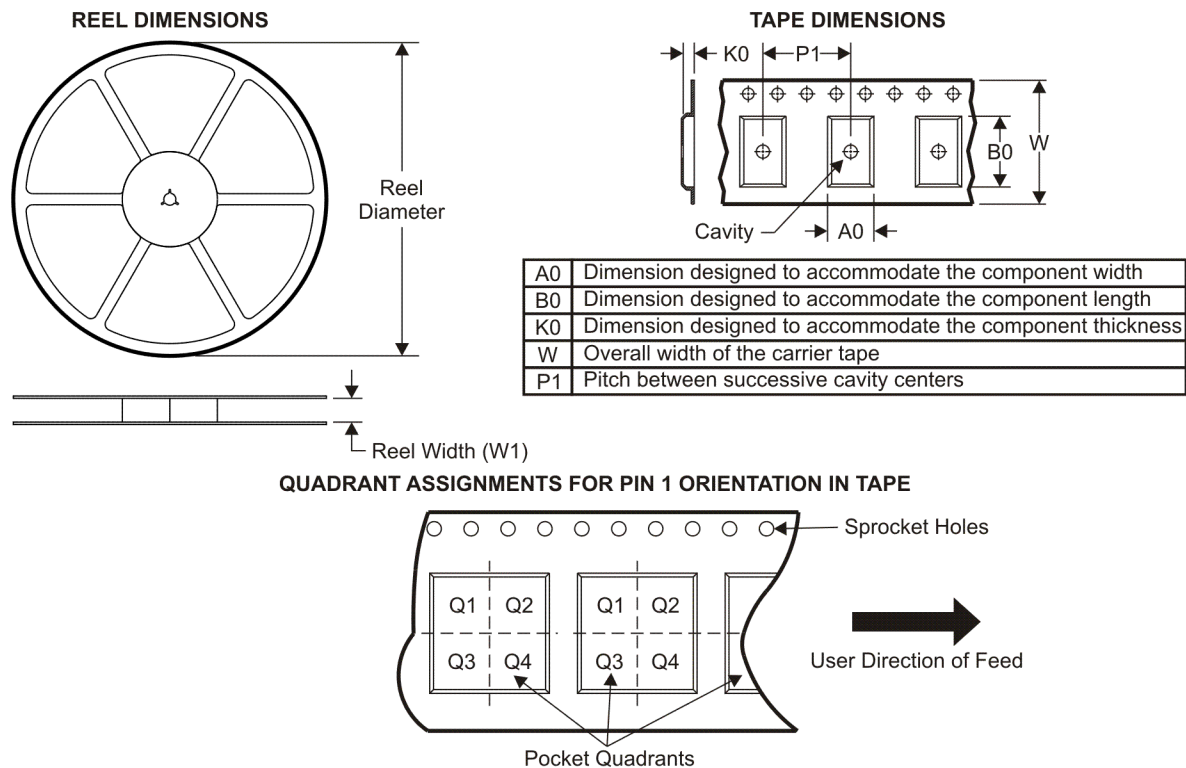
**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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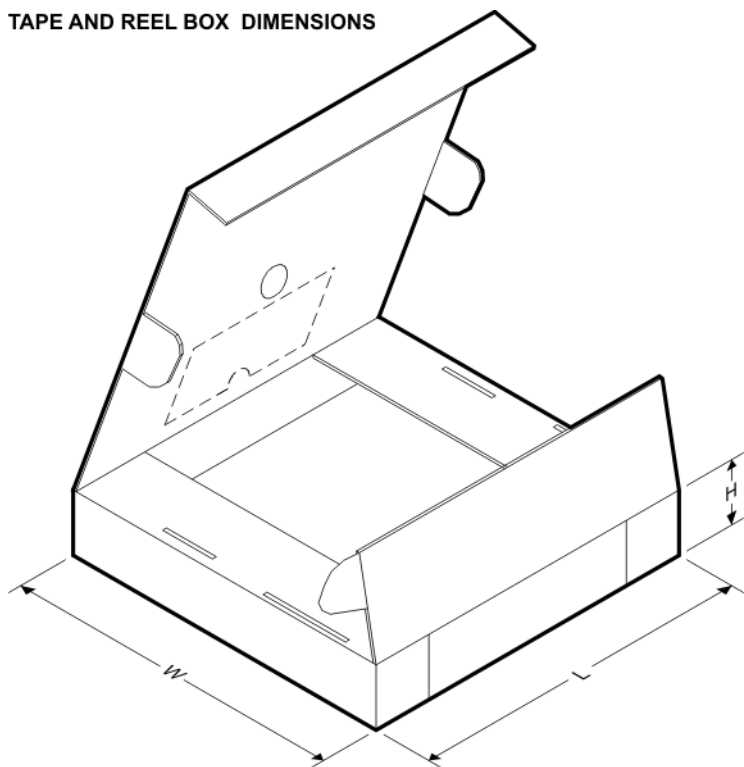
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**TAPE AND REEL INFORMATION**


\*All dimensions are nominal

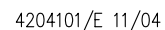
| Device       | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| ADS5545IRGZR | VQFN         | RGZ             | 48   | 2500 | 330.0              | 16.4               | 7.3     | 7.3     | 1.5     | 12.0    | 16.0   | Q2            |
| ADS5545IRGZT | VQFN         | RGZ             | 48   | 250  | 330.0              | 16.4               | 7.3     | 7.3     | 1.5     | 12.0    | 16.0   | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ADS5545IRGZR | VQFN         | RGZ             | 48   | 2500 | 333.2       | 345.9      | 28.6        |
| ADS5545IRGZT | VQFN         | RGZ             | 48   | 250  | 333.2       | 345.9      | 28.6        |



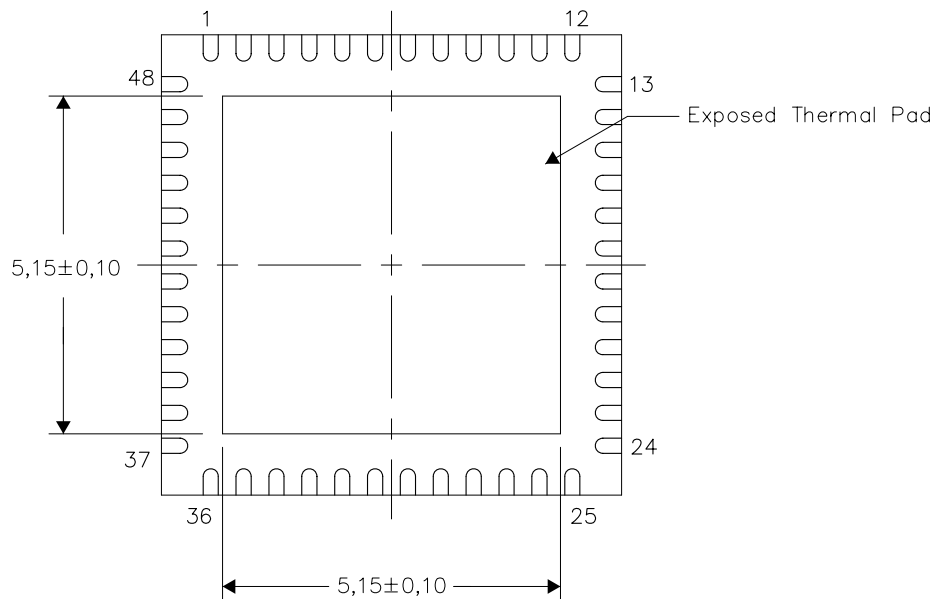
E. Falls within JEDEC MO-220.

### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

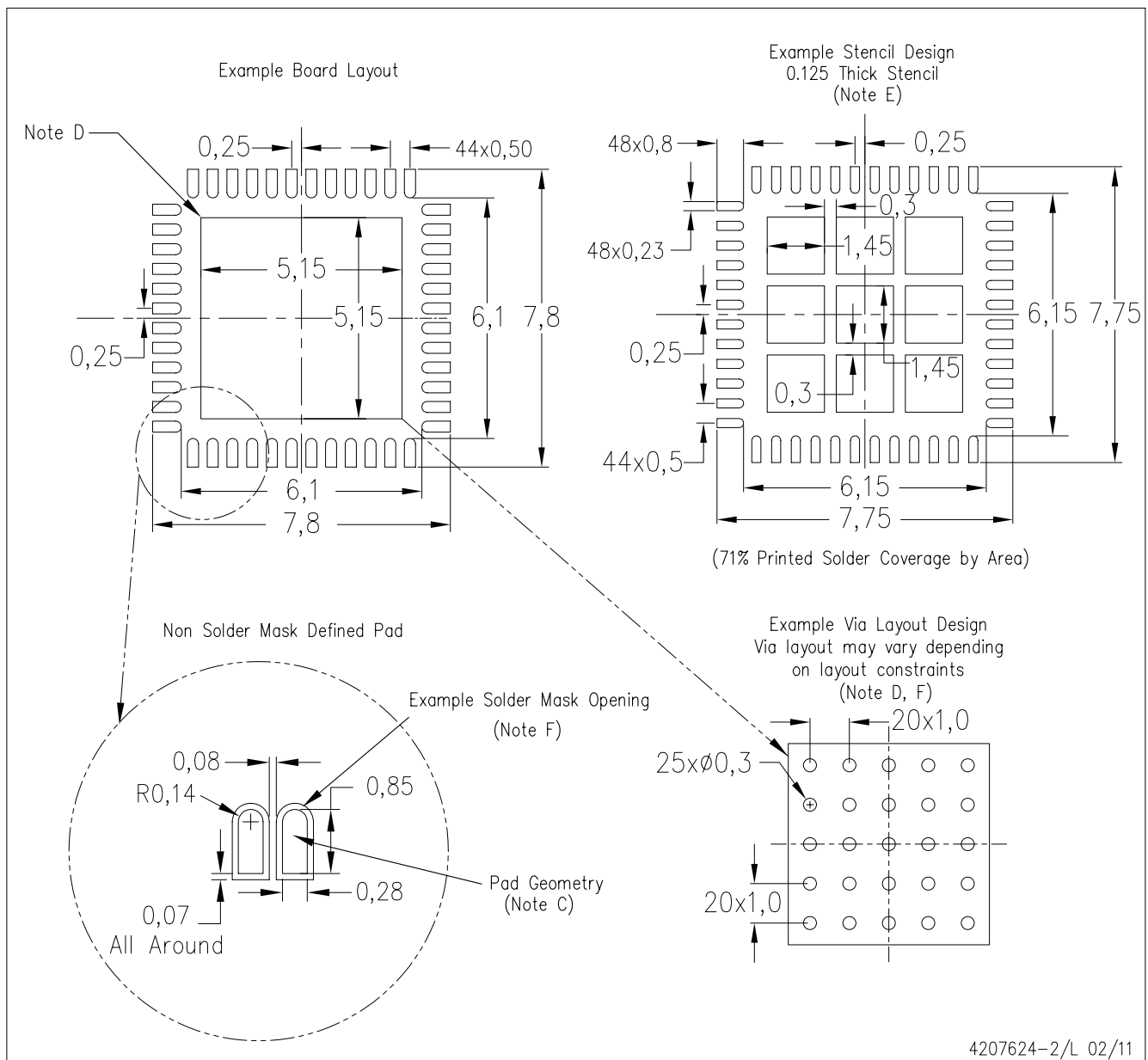
4206354-2/P 02/11

NOTE: A. All linear dimensions are in millimeters



RGZ (S-PVQFN-N48)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.

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